

Renesas RA Family

RA2 Quick Design Guide

Introduction

This document answers common questions and points out subtleties of the RA2 MCU that might be missed unless the hardware manual was extensively reviewed. The document is not intended to be a replacement for the hardware manual. It is intended to supplement the manual by highlighting some key items most engineers will need to start their own design. It also discusses some design decisions from an application point of view.

Target Device

RA2 MCU Series

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1. Power Supplies

The RA family has digital power supplies and analog power supplies. The power supplies use the following pins.

Table 1. Digital Power Supplies

Symbol	Name	Description
VCC	Power supply	Power supply pin. Connect to the system power supply. Connect this pin to VSS via a 0.1 μ F capacitor placed close to the VCC pin.
VSS	Ground	Ground.
VCL	Power supply	Connect this pin to VSS via a capacitor close to the VCL pin. The value depends upon the specific MCU group.
VCC_USB ^{*1}	USB FS power supply	USB Full-Speed power supply pin. Connect this pin to VCC. Connect this pin to VSS_USB via a 0.1 μ F capacitor placed close to the VCC_USB pin.
VSS_USB	USB FS ground	USB Full-Speed ground pin. Connect this pin to VSS.
VCC_DCDC ^{*2}	Switching regulator power supply	In DCDC mode, connect this pin to VCC. Connect this pin to VSS through a 1.0 μ F capacitor placed close to the VCC_DCDC pin. In LDO mode, leave this pin open.
VSS_DCDC ^{*2}	Switching regulator ground pin	In DCDC mode, connect this pin to VSS. In LDO mode, leave this pin open.
VLO	Switching regulator pin	In DCDC mode, connect this pin to an external inductor then connect it to VCL pin. Place the inductor and capacitor close to the pin.

Notes 1: Only used on RA2A1. VCC_USB can be either input or output. As input, it supplies the USB transceiver. As output, it is the voltage out from the USB LDO Regulator, and needs an external capacitor. When the USB LDO Regulator is not used, connect to VCC. When the regulator is used, connect to VSS through a 1.0 μ F capacitor.

2: Only used on RA2L1. Please see the *Internal Voltage Regulator* chapter in the RA2L1 Hardware User's Manual for implementation guidelines.

Table 2. Analog Power Supplies

Symbol	Name	Description
AVCC0 ^{*3}	Analog power supply	Analog voltage supply pin for the respective modules. Connect this pin to the same voltage as the VCC pin.
AVSS0 ^{*3}	Analog ground	Analog ground for the respective modules. Connect this pin to the same voltage as the VSS pin.
VREFH0 ^{*1}	12-bit ADC high reference voltage	Reference voltage input pin for the 12-bit A/D. Connect this pin to AVCC0 if the 12-bit A/D converter is not used. ^{*4}

VREFL0 ^{*1}	12-bit ADC low reference voltage	Analog reference ground pin for the 12-bit A/D converter. Connect this pin to AVSS0 if the 12-bit A/D converter is not used. ^{*4}
VREFH ^{*2}	12-bit DAC analog supply	Reference voltage input pin for the D/A converter. Connect this pin to AVCC0 if the D/A converter is not used.
VREFL ^{*2}	12-bit DAC analog ground	Reference ground pin for the D/A converter. Connect this pin to AVSS0 if the D/A converter is not used.
AVCC1 ^{*2}	24-bit SDADC analog supply voltage	Analog voltage supply pin for the 24-bit SDADC module.
AVSS1 ^{*2}	24-bit SDADC analog ground	Analog ground pin for the 24-bit SDADC module.
VREFI ^{*2}	24-bit SDADC external reference supply	External voltage reference for the 24-bit SDADC, multiplexed with the SBIAS output. As an input, this pin has a voltage range of 0.8 V to 2.4 V, set in 0.2-V increments. Connect this pin to AVSS1 through a 0.22 μ F capacitor.

Notes 1: For RA2A1, this applies to the 16-bit ADC.

2: Present on RA2A1 only.

3: Not present on RA2E2

4: For RA2E2, connect VREFH0 to VCC and VREFL0 to VSS if the 12-bit ADC is not used.

1.1 References

Further information regarding the power supply for the RA MCU Group can be found in the following documents:

- R01UH0888 RA2A1 Group, *RA2A1 Group User's Manual: Hardware*
- R01UH0852 RA2E1 Group, *RA2E1 Group User's Manual: Hardware*
- R01UH0919 RA2E2 Group, *RA2E2 Group User's Manual: Hardware*
- R01UH0853 RA2L1 Group, *RA2L1 Group User's Manual: Hardware*

Chapter numbers may vary between devices.

The **Overview** chapter lists power pins in each package with recommended bypass capacitors.

The **Resets** chapter discusses the Power-On Reset and how to differentiate this from other reset sources.

The **Low Voltage Detection** chapter provides details on the Low-Voltage Detection Circuit that can be used to monitor the power supply. The **Option-Setting Memory** chapter additionally describes how to enable Low-Voltage Detection 0 Circuit automatically at startup.

If you plan to use the on-chip Analog to Digital Converters (ADC) or the Digital to Analog Converter (DAC), refer to one of the following chapters in the respective Hardware User's Manuals for details on how to provide filtered power supplies for these peripherals:

- *12-Bit A/D Converter (ADC12)*
- *16-Bit A/D Converter (ADC16)*
- *24-Bit Sigma-Delta A/D Converter (SDADC24)*
- *8-Bit D/A Converter (DAC8)*
- *12-Bit D/A Converter (DAC12)*

Table 3. RA2 MCU Groups, User's Manual: Hardware

Chapter Name	Description
Overview	Lists power pins in each package with notes on termination and bypassing.
Resets	Discusses the Power-On Reset and how to differentiate this from other reset sources.
Low Voltage Detection	Provides details on the Low-Voltage Detection Circuit that can be used to monitor the power supply.
Low Power Modes	Using low power modes may allow you to reduce the voltage of

Chapter Name	Description
	the power supply. See this chapter for details on how operating modes affect power supply requirements.
12-Bit A/D Converter 16-Bit A/D Converter 24-Bit Sigma-Delta A/D Converter 8-Bit D/A Converter 12-bit D/A Converter	If you plan to use the on-chip A/D or D/A converters, these chapters give details on how to provide filtered power supplies for these peripherals.
Clock Generation Circuit	Provides detailed descriptions on how to configure and use the available clocks, including PCB design recommendations.

2. Emulator Support

RA2 MCU devices have an emulator interface that supports both debugging using SWD communication and serial programming using SCI communication. This emulator makes it easy to switch between debugging and serial programming.

The SWD emulator interface can be connected to an Arm®-standard 10-pin or 20-pin socket. TXD and RXD pins are added for serial programming using SCI communication.

To comply with the Arm® specification, pull up resistors are required on the SWD and SCI signals. Without the correct pull up resistors, the interface may not function correctly. However, RA2 MCU devices have internal pull up resistors that are enabled by default for these signals. When the internal pull up resistors are enabled, no external resistors are required on these signals.

Emulator support is useful for product development and prototyping, but may not be needed once a design moves to production. If emulator support is no longer needed for a design, make sure to configure the ports according to the *Handling of Unused Pins* section of the related MCU Hardware User's Manual. Also see section 9.5 in this document.

2.1 SWD Interface

The following diagram shows the typical connectivity of the debug interface when using Serial Wire Debug (SWD).

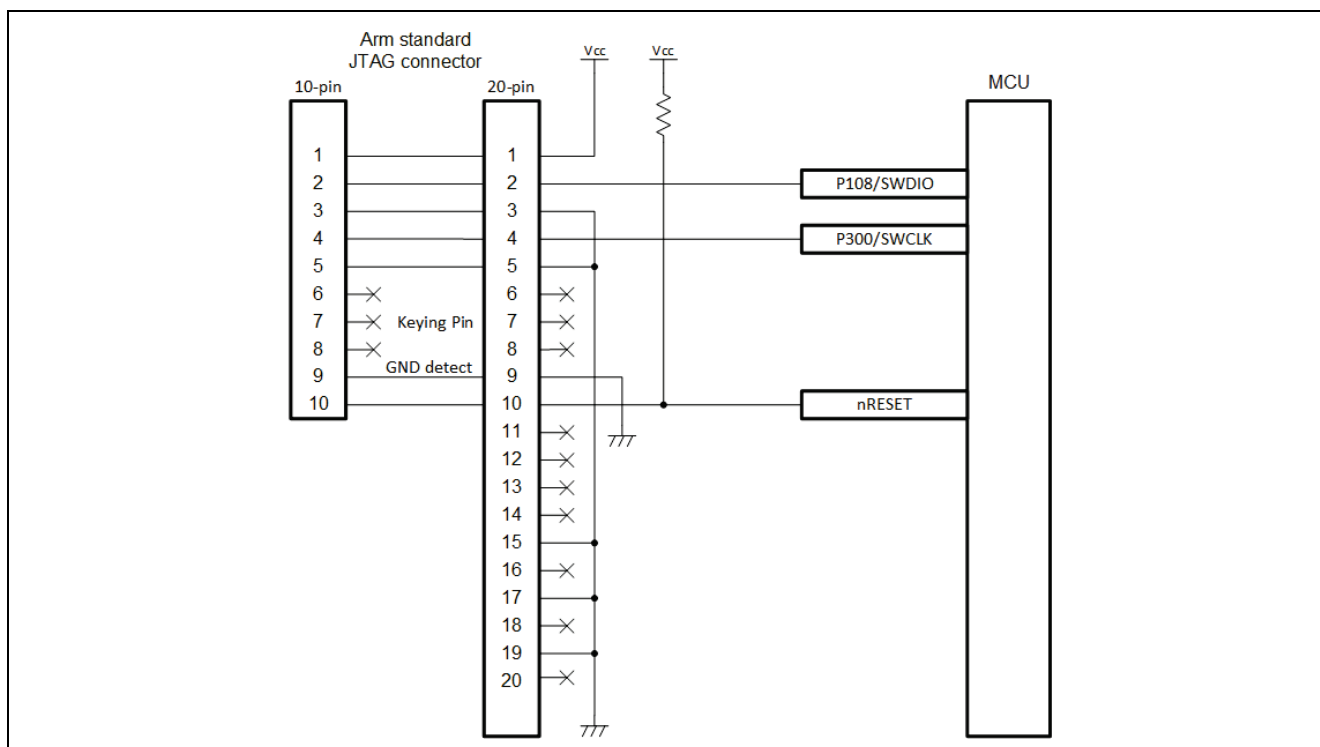


Figure 1. SWD Interface Connections

Note: The output of the reset circuit of the user system must be open collector.

2.2 Serial Programming Interface using SCI

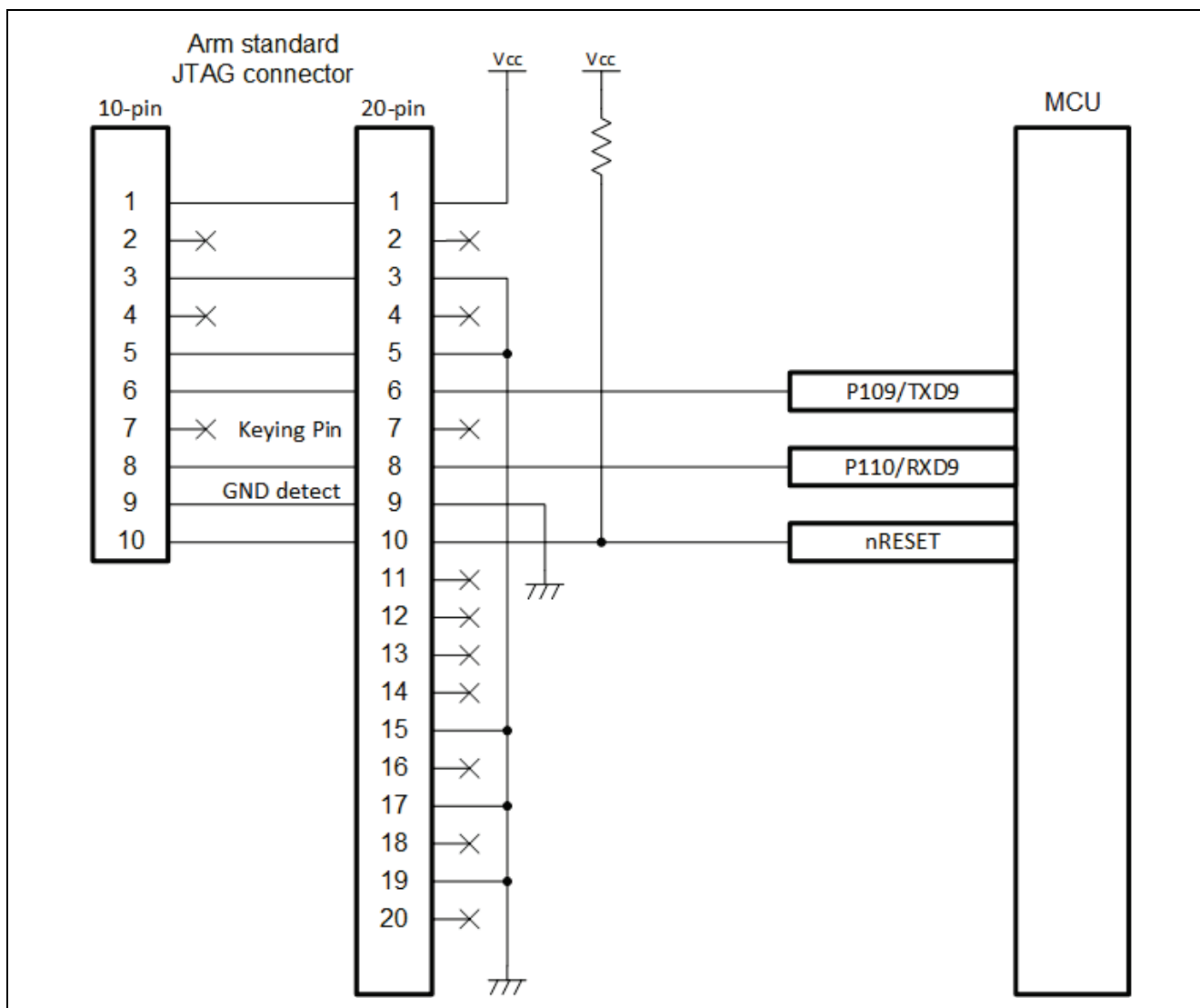


Figure 2. Serial Programming Interface using SCI Connections

Note: The output of the reset circuit of the user system must be open collector.

2.3 Combination Debug Interface

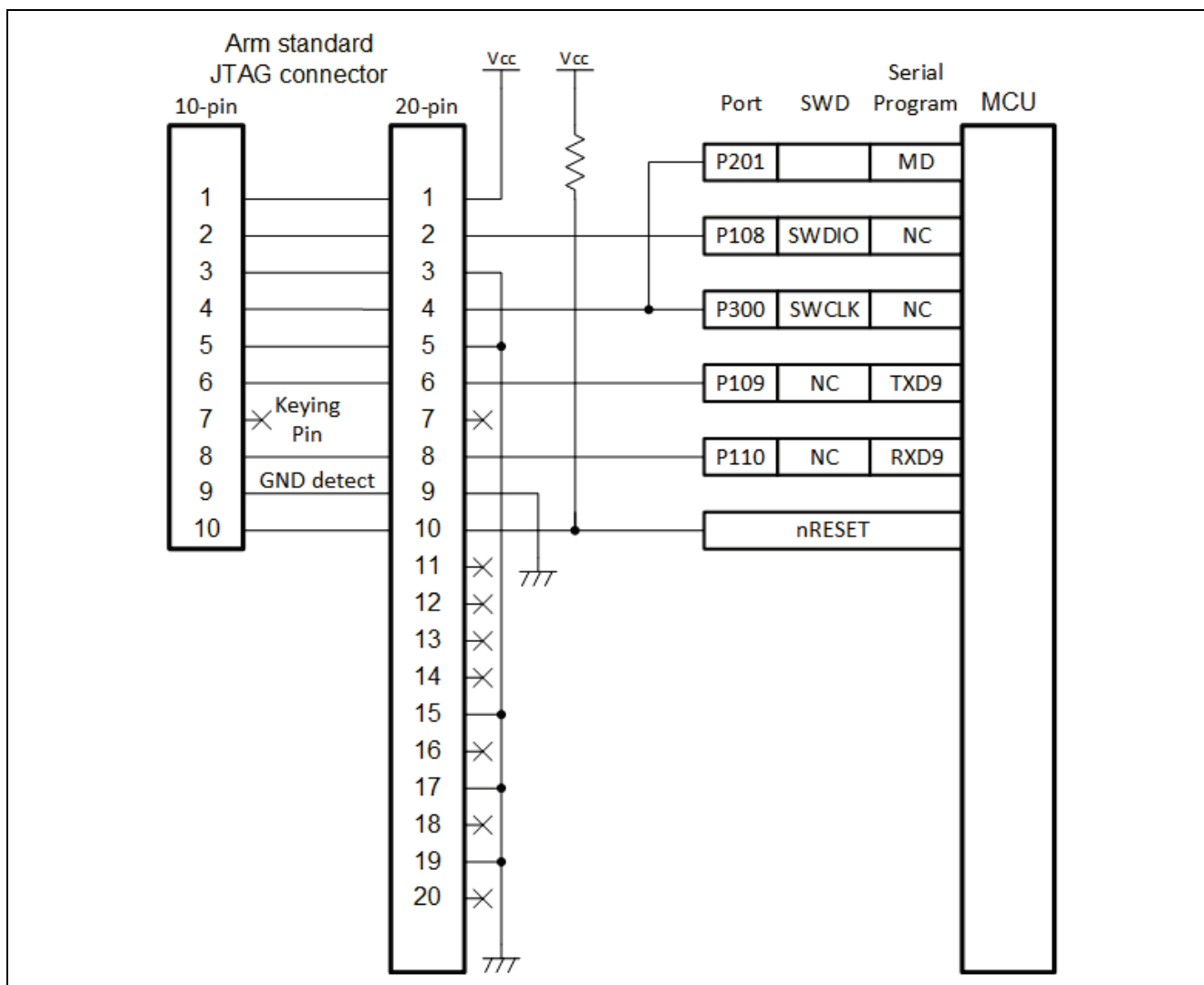


Figure 3. Debug Interface for both SWD and Programming with SCI Connections

Note: The output of the reset circuit of the user system must be open collector.

P201/MD can be connected to P300/SWCLK to allow the debugger to control the MCU Operating Mode. See section 3 for more details.

3. MCU Operating Modes

The RA2 MCU series can enter one of two modes after reset: Single-chip mode or SCI/USB boot mode. The boot mode is selected by the MD pin:

Table 4. Operating Modes Available at Reset

Operating Mode	MD	On-Chip Flash Memory
Single-chip mode	1	Enable
SCI/USB boot mode	0	Enable

Figure 4 shows operating mode transitions as determined by the Mode-Setting (MD) pin.

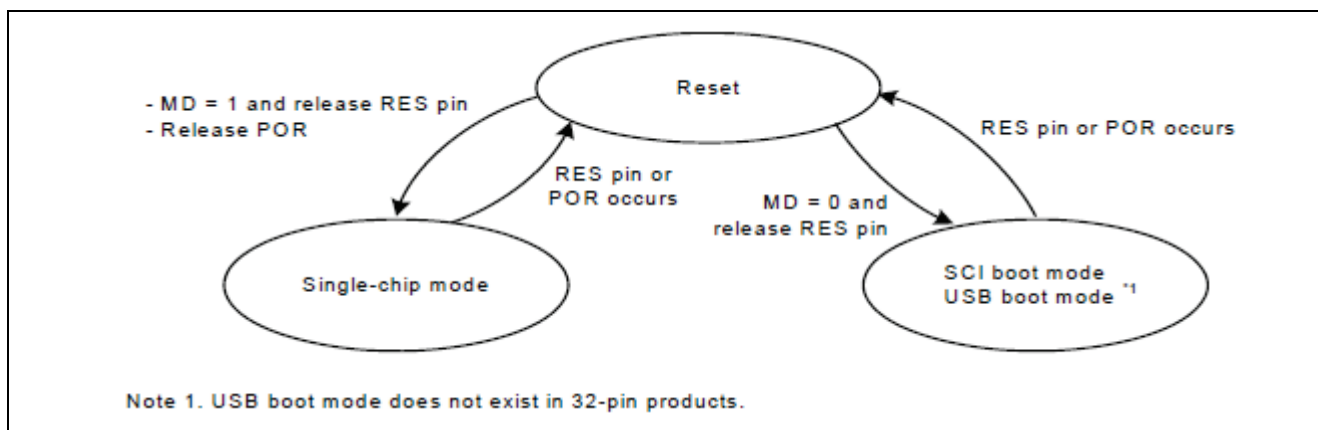


Figure 4. Mode Setting Pin Level and Operating Mode

Note: USB boot mode is only available on devices that have the USB Full-Speed peripheral, such as RA2A1. For the RA2A1 MCU group, USB boot mode does not exist in 32-pin products.

A typical MCU boot mode circuit includes a jumper and a couple of resistors to allow selections to connect the MD pin to VCC or Ground. RA2 MCU devices include an internal pull up resistor on P201/MD, which is enabled by default. The internal pull up resistor may replace the external pull up resistor in Figure 5.

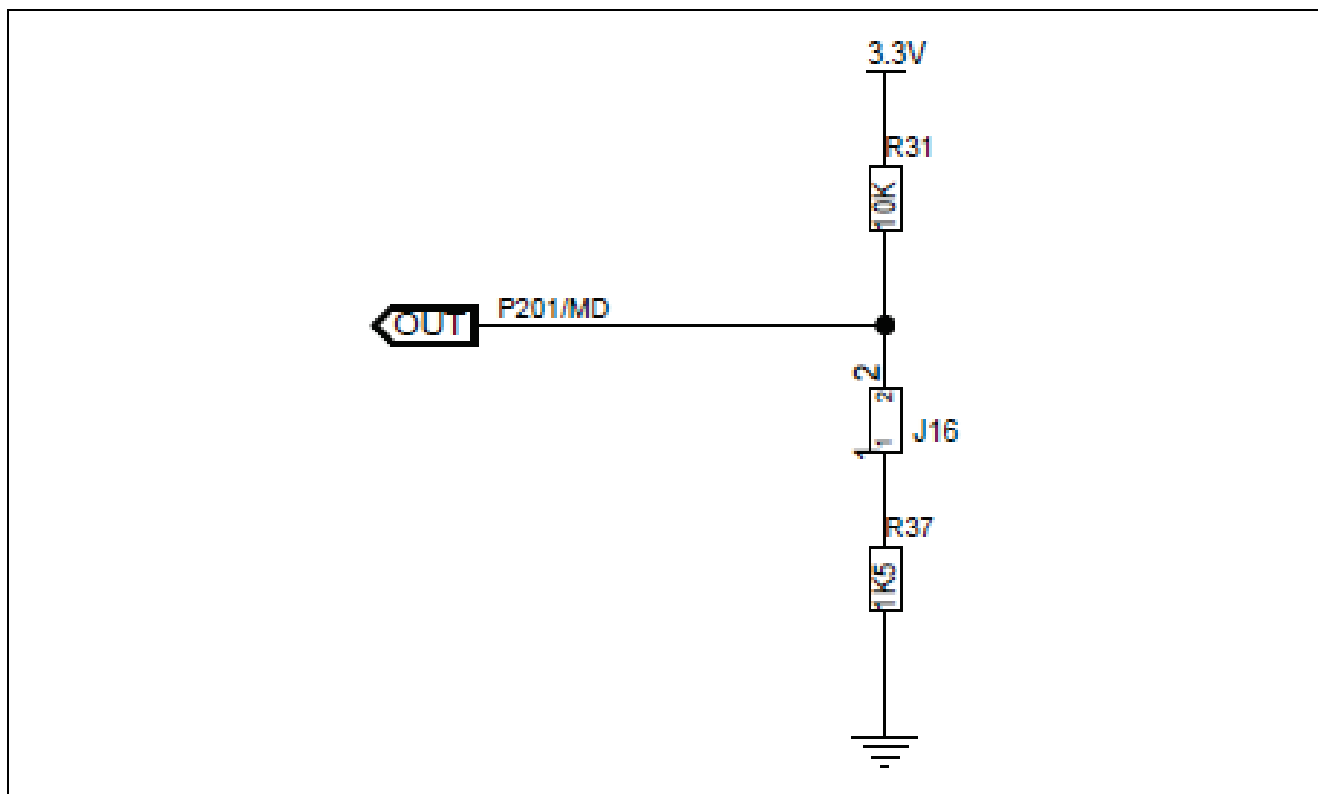


Figure 5. Typical Circuit for MCU Boot Mode Selection

4. Option Setting Memory

The option setting memory determines the state of the MCU after a reset. It is allocated to the configuration setting area and the program flash area of the flash memory. The available methods of setting are different for the two areas.

The registers are detailed in the *Option Setting Memory* chapter in the Hardware User's Manual.

The flash option registers occupy space in the code flash memory map. Although the registers are located in a portion of the flash memory that was reserved on the RA MCUs, **it is possible that some customers may store data in these locations inadvertently**. The user must check to ensure that no unwanted data is written to these locations or else unexpected behavior of the chip may result. Additionally, when using binary files for programming, the user must ensure that reserved areas of memory are not programmed due to the addresses of the configuration setting area. For instance, settings in the flash option registers can enable the Independent Watchdog Timer (IWDG) immediately after reset. If data stored in program ROM inadvertently overlaps the option setting memory register, it is possible to turn on the IWDG on without realizing it. This will cause the debugger to have communications problems with the board.

The figure below shows the option setting memory area, which consists of the option function select registers on RA2A1. The Option Setting Memory may be different for each device. Please consult MCU User's Manual for the specific device details.

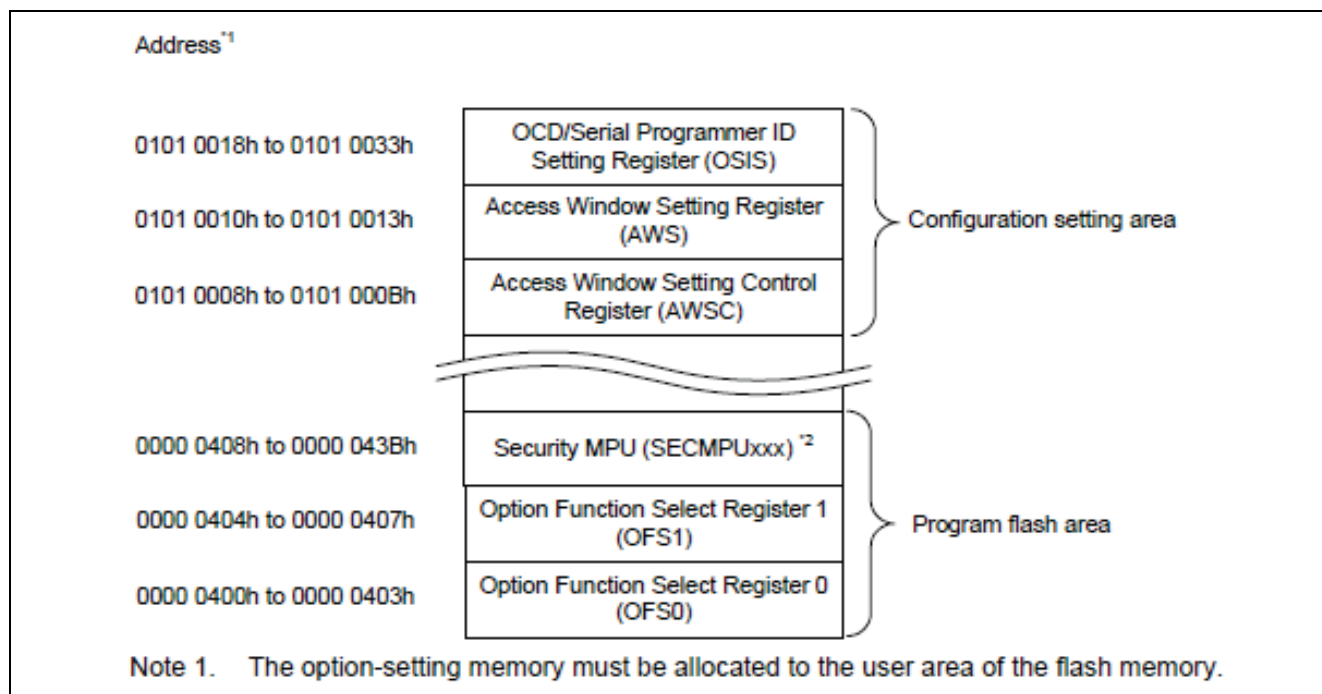


Figure 6. Option Function Select Registers for RA2A1

4.1 Option Setting Memory Registers

The following is a summary of the Option Setting Memory registers. Make sure that they are configured properly before startup.

- OFS0 register
 - Independent Watchdog Timer (IWDT) auto start
 - IWDT timeout, frequency, windowing, interrupt type, and low power mode behavior
 - Watchdog Timer (WDT) auto start
 - WDT timeout, frequency, windowing, and interrupt type
- OFS1 register
 - LVD0 enable after reset
 - HOCO startup after reset

Renesas FSP Configurator supports setting of option memory in BSP settings, as shown in Figure 7 for RA2A1 MCU.

Settings	Property	Value
	> R7FA2A1AB3CFM	
	> RA2A1	
	▼ RA2A1 Family	
	▼ OFS0 register settings	
	▼ Independent WDT	
	Start Mode	IWDT is Disabled
	Timeout Period	2048 cycles
	Dedicated Clock Frequency Divisor	128
	Window End Position	0% (no window end position)
	Window Start Position	100% (no window start position)
	Reset Interrupt Request Select	Reset is enabled
	Stop Control	Stop counting when in Sleep, Snooze mode, or Software Standby
	▼ WDT	
	Start Mode Select	Stop WDT after a reset (register-start mode)
	Timeout Period	16384 cycles
	Clock Frequency Division Ratio	128
	Window End Position	0% (no window end position)
	Window Start Position	100% (no window start position)
	Reset Interrupt Request	Reset
	Stop Control	Stop counting when entering Sleep mode
	▼ OFS1 register settings	
	Voltage Detection 0 Circuit Start	Voltage monitor 0 reset is disabled after reset
	Voltage Detection 0 Level	1.90 V
	HOCO Oscillation Enable	HOCO oscillation is enabled after reset
	> MPU	
	Use Low Voltage Mode	Disabled
	Main Oscillator Wait Time	262144 cycles
	ID Code Mode	Unlocked (Ignore ID)
	ID Code (32 Hex Characters)	FFFFFFFFFFFFFFFFFFFFFFFFFFFFFFFF
	> RA Common	

Figure 7. Option Memory Settings in FSP Configuration for RA2A1 MCU

5. Clock Circuits

Most RA2 MCUs have six primary oscillators. Five of these may be used as the source for the main system clock. The remaining oscillator is dedicated to the Independent Watchdog Timer. In a typical system, the main clock is driven with an external crystal or clock. This input is directed to internal selectors and frequency dividers, where it is further directed to the main system clock (ICLK), flash clock, CPU clock, and peripheral module clocks. For some devices, the clock distribution also includes additional clocks for ADC and USB peripherals.

Note: RA2E2 devices do not have external crystal or clock input pins. Refer to the *Clock Generation Circuit* chapter in the *Hardware User's Manual's* for the block diagram of the clock generation circuit.

Each clock has specific tolerances and timing values. Refer to the Hardware User's Manual's AC Characteristics section in the Electrical Characteristics chapter for the Frequency and Clock Timing specifications. Refer to the Hardware User's Manual's Clock Generation Circuit chapter for the relationship between the various clock frequencies.

Table 5. RA2 Oscillators

Oscillator	Input Source	Frequency	Primary Uses
Main clock ^{*4} (MOSC)	External crystal/resonator -or-	1 MHz to 20 MHz ^{*3}	Main system clock (ICLK), Peripheral clocks, CAN clock, CAC clock, CLKOUT, flash clock ^{*3} , SDADC clock ^{*1}
	External clock	Up to 20 MHz	
Sub-clock ^{*4} (SOSC)	External crystal/resonator	32.768 kHz	Real-time clock, main system clock (ICLK) in low power modes, CLKOUT, AGT clock, CAC clock
High-speed on-chip (HOCO)	On-chip oscillator	24/32/48/64 MHz	Main system clock (ICLK), Peripheral clocks, CAC clock, CLKOUT, USB clock ^{*2} , SDADC clock ^{*1}
Middle-speed on-chip (MOCO)	On-chip oscillator	8 MHz	Main system clock (ICLK) at startup, Peripheral clocks, CLKOUT, CAC clock
Low-speed on-chip (LOCO)	On-chip oscillator	32.768 kHz	Main system clock (ICLK) in low power modes and during main oscillator stop detection, Peripheral clocks, SysTick timer, AGT clock, CLKOUT, CAC clock, Real-Time clock, Independent Watchdog Timer clock
Independent Watchdog (IWDT)	On-chip oscillator	15 kHz	Independent Watchdog Timer clock, CAC clock

Note 1: SDADC clock is only present on RA2A1 devices.

2: USB clock is only present on RA2A1 devices.

3: On RA2A1 devices, the flash clock (FCLK) is driven independently from MOSC, and can be sourced from MOSC, SOSC, HOCO, MOCO, or LOCO.

4: Not present on RA2E2

Some devices, such as RA2E2, do not include the option for an external crystal or clock. In this case, the oscillator sources for the main clock are limited to the on-chip oscillators.

5.1 Reset Conditions

After reset, RA2 MCUs begin running with the middle-speed on-chip oscillator (MOCO) as the main clock source. At reset, the main oscillator is stopped by default. The HOCO and IWDG may be on or off depending on the settings in the Option Setting Memory (see section 4).

5.2 Clock Frequency Requirements

Minimum and maximum frequencies are shown in the following tables. Details can be found in the Overview section of the Clock Generation Circuit chapter in the MCU Hardware User's Manual, including external and internal clock source specifications. Additional details can be found in the *AC Characteristics* section of the *Electrical Characteristics* chapter in the MCU Hardware User's Manual.

Table 6. Frequency Range for RA2 MCU Internal Clocks

	ICLK ⁴	PCLKB	PCLKD	FCLK ¹	UCLK ²	CANMCLK ³
Maximum Frequency [MHz]	48	32	64	32	48	20
Minimum Frequency [MHz]	—	—	—	1	48	1

Note 1: Only on RA2A1. The FCLK must run at a frequency of at least 1 MHz when programming or erasing ROM or data flash.

2: For devices with USB peripheral function.

3: For devices with CAN peripheral function.

4: For RA2E1, RA2E2, and RA2L1, ICLK must run at a frequency of at least 1 MHz when programming or erasing ROM or data flash.

5.2.1 Requirements for USB Communications

The USB 2.0 Full-Speed Module (USBFS) requires a 48 MHz USB clock signal (UCLK).

For RA2 devices with a USBFS Module, the HOCO is the clock source for UCLK. Therefore, the HOCO must be configured for 48 MHz operation when the USBFS Module is used.

5.2.2 Requirements for Programming and Erasing ROM or Data Flash

For RA2A1, the FCLK must be at least 1 MHz to perform programming and erasing on internal ROM and data flash.

For all other RA2 devices, the ICLK must be at least 1 MHz to perform programming and erasing on internal ROM and data flash.

5.3 Lowering Clock Generation Circuit (CGC) Power Consumption

To aid in saving power, set the dividers for any unused clocks to the highest possible value whenever possible. Also, if not using a clock, then make sure that it has been stopped by setting the appropriate register(s). The registers for controlling each clock source are shown in the table below.

Table 7. Clock Source Configuration Registers

Oscillator	Register	Description
Main clock ^{*1}	MOSCCR	Starts/stops main clock oscillator
Sub-clock ^{*1}	SOSCCR	Starts/stops sub-clock oscillator
High-speed on-chip (HOCO)	HOCOCR	Starts/stops HOCO
Middle-speed on-chip (MOCO)	MOCOCR	Starts/stops MOCO
Low-speed on-chip (LOCO)	LOCOCR	Starts/stops LOCO

Note 1: Not present on RA2E2 devices.

5.4 Writing the System Clock Control Registers

Care should be taken when writing to the individual bit fields in the System Clock Division Control Register (SCKDIVCR) and System Clock Source Control Register (SCKSCR).

When the clock source of the peripheral module clock is switched, the duration of the peripheral module clock cycle becomes longer during the clock source transition period. See Figure 8.

To ensure correct processing after the clock frequency changes, first write to the relevant Clock Control register to change the frequency, then read the value from the register, and finally perform the subsequent processing.

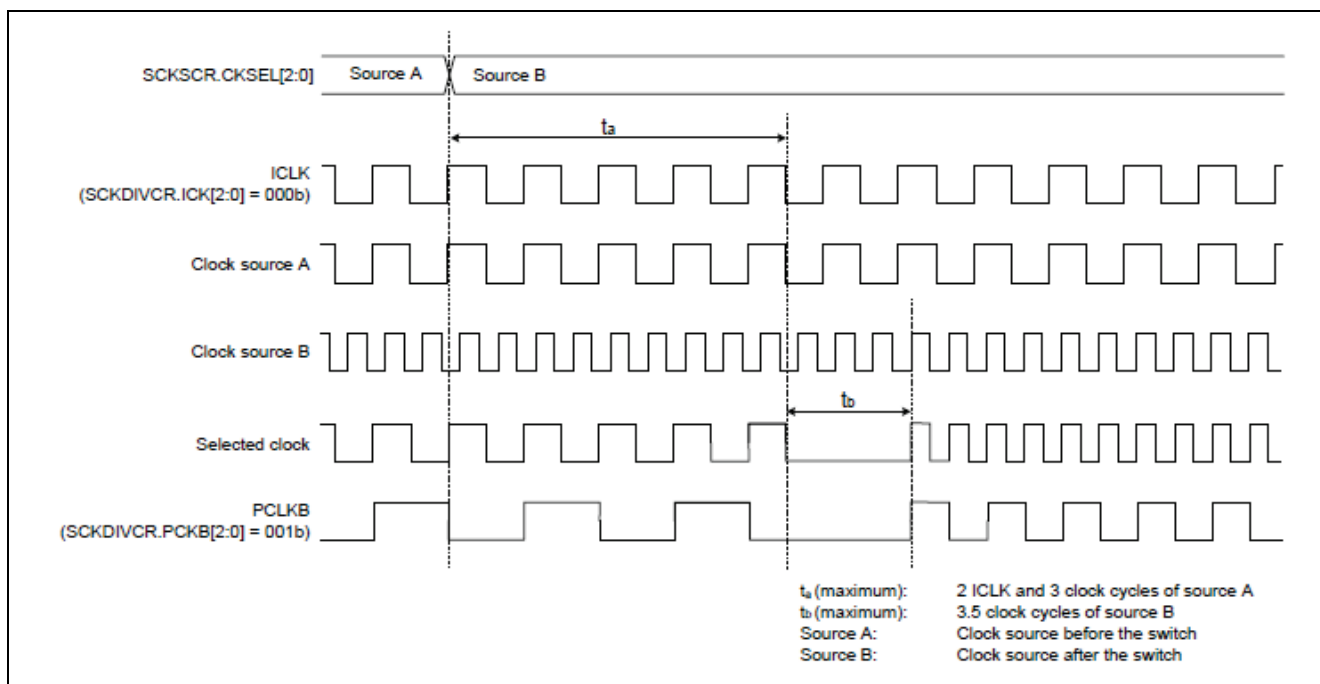


Figure 8. Timing of Clock Source Switching

5.5 Clock Setup Example

Renesas FSP provides a simple, visual clock configuration tool for RA2A1 MCU shown as follows. This configurator configures code in the board support package to initialize the Clock Generation Circuit based on user selection, with proper precautions as indicated in the MCU Hardware User's Manual.

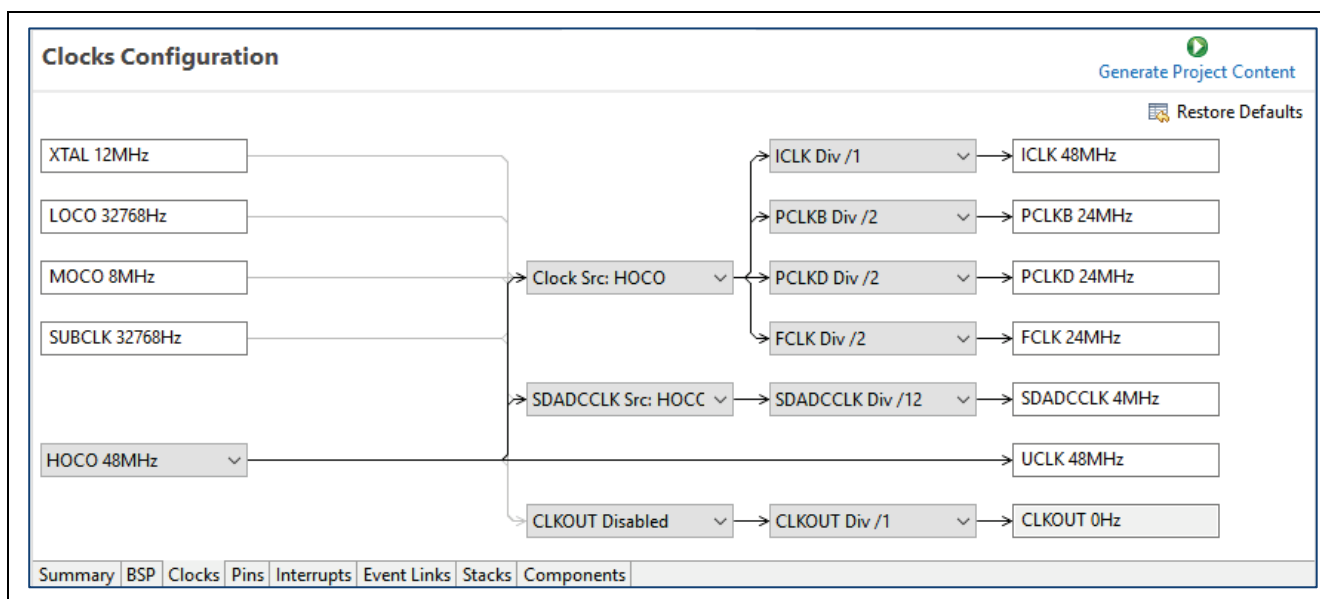


Figure 9. Clock Settings Using Renesas FSP Configurator

5.6 HOCO Accuracy

The internal high-speed on-chip oscillator (HOCO) runs at 24 MHz, 32 MHz, 48 MHz, or 64 MHz for RA2 devices, with a typical accuracy of $\pm 2\%$ or better. HOCO accuracy specifications are characterized for various ambient operating temperature (T_a) ranges. See the Electrical Characteristics of the *Hardware User's Manual* for the clock accuracy specifications in the desired temperature range.

The HOCO may be used as an input to the clock generation circuit. When the HOCO is used this way, no external oscillator is required. This may be an advantage when space constraints or other limitations require a reduced component count in a PCB design. However, there are performance tradeoffs and limitations due to the clock accuracy which should be evaluated for your application.

For RA2E2 devices, there are no external crystal or external clock inputs. An internal clock (HOCO, MOCO, or LOCO) must be selected as the main system clock.

5.7 Flash Interface Clock

On RA2A1 devices, the Flash Interface Clock (FCLK) is used as the operating clock when programming and erasing internal flash (ROM and DF) and for reading from the data flash. For other RA2 devices, ICLK is used as the operating clock when programming and erasing the internal flash.

Therefore, the frequency setting of the relevant clock will have a direct impact on the amount of time it takes to read from the data flash. If the user's program is reading from the data flash, or performing programming or erasures on internal flash, then using the maximum FCLK or ICLK frequency is recommended.

The flash programming clock must run at a frequency of at least 1 MHz when writing or erasing ROM or data flash. Please note that the clock frequency does not have any impact upon reading from ROM or reading and writing to RAM.

5.8 Board Design

Refer to the *Usage Notes* section of the *Clock Generation Circuit (CGC)* chapter in the Hardware User's Manual for more information on using the CGC and for board design recommendations.

In general, place the crystal resonator and its load capacitors as close to the MCU clock pins (XTAL/EXTAL, XCIN/XCOUT) as possible. Avoid routing any other signals between the crystal resonator and the MCU. Minimize the number of connecting vias used on each trace.

5.9 External Crystal Resonator Selection

An external crystal resonator may be used as the main clock source for most RA2 devices. The external crystal resonator is connected across the EXTAL and XTAL pins of the MCU. The frequency of the external crystal resonator must be in the frequency range of the main clock oscillator.

Selection of a crystal resonator will be largely dependent on each unique board design. Due to the large selection of crystal resonators available that may be suitable for use with RA2 MCU devices, carefully evaluate the electrical characteristics of the selected crystal resonator to determine the specific implementation requirements.

The following diagram shows a typical example of a crystal resonator connection.

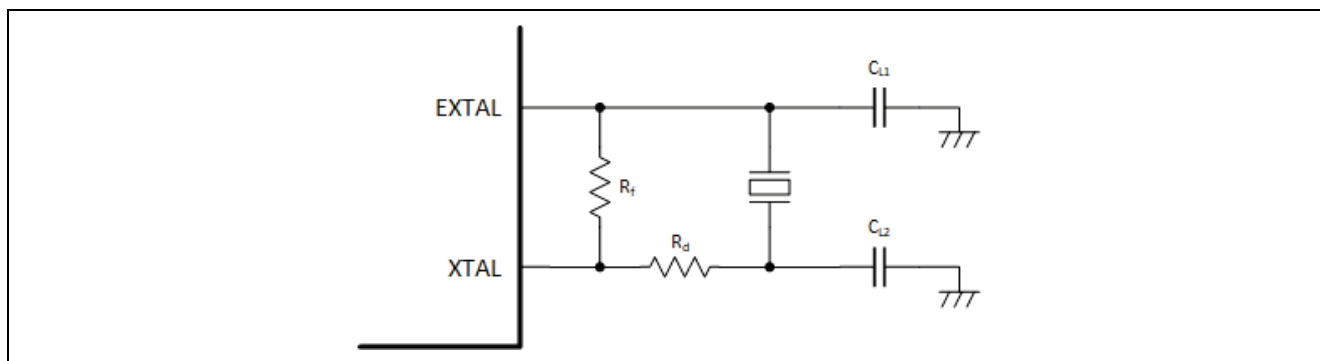


Figure 10. Example of Crystal Resonator Connection

Careful evaluation must be used when selecting the crystal resonator and the associated capacitors. The external feedback resistor (R_f) and damping resistor (R_d) may be added if recommended by the crystal resonator manufacturer.

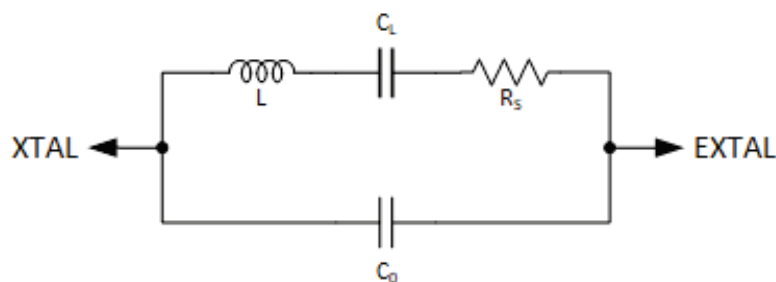


Figure 11. Equivalent Circuit of the Crystal Resonator

Selection of the capacitor values for CL1 and CL2 will affect the accuracy of the internal clock. To understand the impact of the values for CL1 and CL2, the circuit should be simulated using the equivalent circuit of the crystal resonator in the figure above. For more accurate results, also take in to account the stray capacitance associated with the routing between the crystal resonator components.

5.10 External Clock Input

A digital clock input may be used as the main clock source for most RA2 devices. Figure 12 shows an example of connecting an external clock input. To operate the oscillator with an external clock signal, set the MOMCR.MOSEL bit to 1. The XTAL pin becomes high impedance.

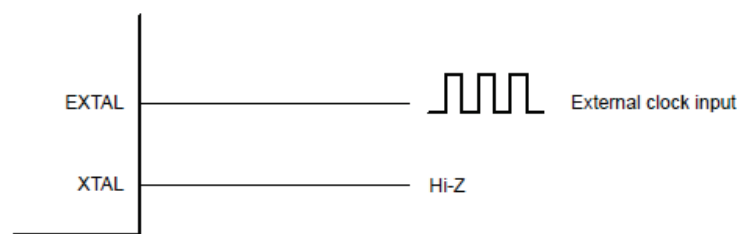


Figure 12. Equivalent circuit for external clock

Note: The frequency of the external clock input can only be changed when the main clock oscillator is stopped. Do not change the frequency of the external clock input when the setting of the Main Clock Oscillator Stop bit (MOSCCR.MOSTP) is 0.

6. Reset Requirements and the Reset Circuit

There are 12 or 13 types of resets for Arm® Cortex®-M23 devices.

Table 8. RA2 Device Resets

Reset Name	Source
Pin reset	RES# is driven low
Power-on reset	VCC rises (voltage detection: VPOR)
Independent watchdog timer reset	The independent watchdog timer underflows, or a refresh occurs
Watchdog timer reset	The watchdog timer underflows, or a refresh occurs
Voltage monitor 0 reset	VCC falls (voltage detection Vdet0)
Voltage monitor 1 reset	VCC falls (voltage detection Vdet1)
Voltage monitor 2 reset	VCC falls (voltage detection Vdet2)
SRAM parity error reset	SRAM parity error detection
SRAM ECC error reset ^{*1}	SRAM ECC error detection
Bus master MPU error reset	Bus master MPU error detection
Bus slave MPU error reset	Bus slave MPU error detection
Stack pointer error reset	Stack pointer error detection
Software reset	Register setting

Note 1: Not present on RA2E1 or RA2E2 devices.

6.1 Pin Reset

When the RES# pin is driven low, all processing is aborted and the MCU enters a reset state. To reset the MCU while it is running, hold RES# low for the specified reset pulse width. Refer to the Reset Timing section of the *Electrical Characteristics* chapter of the *Hardware User's Manual* for more detailed timing requirements. Also refer to section 2, Emulator Support for details on reset circuitry in relation to debug support.

There is no need to use an external capacitor on the RES# line because the POR circuit holds it low internally for a good reset and a minimum reset pulse is required to initiate this process.

6.2 Power-On Reset

There are two conditions that will generate a power-on reset (POR):

1. If the RES# pin is in a high-level state when power is supplied.
2. If the RES# pin is in a high-level state when VCC is below V_{POR} .

After VCC has exceeded the power-on reset voltage (V_{POR}) and the power-on reset time (t_{POR}) has elapsed, the chip is released from the power-on reset state. The power-on reset time is a period that allows for stabilization of the external power supply and the MCU. Refer to the POR and LVD Characteristics section of the *Electrical Characteristics* chapter of the *Hardware User's Manual* for voltage level and timing details.

Because the POR circuit relies on having RES# high concurrently with VCC, do not place a capacitor on the reset pin. This will slow the rise time of RES# in relation to VCC, preventing the POR circuit from properly recognizing the power-on condition.

If the RES# pin is high when the power supply (VCC) falls to or below V_{POR} , a power-on reset is generated. The chip is released from the power-on state after VCC has risen above V_{POR} and the t_{POR} has elapsed.

After a power on reset, the PORF bit in RSTSR0 is set to 1. Following a pin reset, PORF is cleared to 0.

6.3 Independent Watchdog Timer Reset

This is an internal reset generated by the Independent Watchdog Timer (IWDT).

When the IWDT underflows, an independent watchdog timer reset is optionally generated (NMI can be generated instead) and the IWDTRF bit in RSTSR1 is set to a 1. After a short delay, the IWDT reset is canceled. Refer to MCU User's Manual for the specific timing.

6.4 Watchdog Timer Reset

This is an internal reset generated by the Watchdog Timer (WDT).

When the WDT overflows, a watchdog timer reset is optionally generated (NMI can be generated instead), and the WDTRF bit in RSTSR1 is set to a 1. After a short delay, the WDT reset is canceled. Refer to MCU User's Manual for the specific timing.

6.5 Voltage-Monitoring Resets

The RA2 MCU family includes circuitry that allows the MCU to protect against unsafe operation during brownouts. On-board comparators check the supply voltage against three reference voltages, V_{det0} , V_{det1} , and V_{det2} . As the supply dips below each reference voltage an interrupt or a reset can be generated. The detection voltages V_{det0} , V_{det1} , and V_{det2} are each selectable from 3 different levels.

When VCC subsequently rises above V_{det0} , V_{det1} , or V_{det2} , release from the voltage-monitoring reset proceeds after a stabilization time has elapsed.

Low Voltage Detection is disabled after a power on reset. Voltage monitoring can be enabled by using the Option Function register OFS1. For more details, see the chapter Low Voltage Detection (LVD) in the *Hardware User's Manual*.

After an LVD Reset, the LVDnRF ($n = 0, 1, 2$) bit in RSTSR0 is set to 1.

6.6 Software Reset

The software reset is an internal reset generated by a software setting of the SYSRESETREQ bit in the AIRCR register in the Arm core. When the SYSRESETREQ bit is set to 1, a software reset is generated. When the internal reset time (tRESW2) elapses after the software reset is generated, the internal reset is canceled, and the CPU starts the reset exception handling. Refer to MCU User's Manual for the specific timing.

For details on the SYSRESETREQ bit, see the Arm® Cortex®-M23 Technical Reference Manuals.

6.7 Other Resets

Most peripheral functions within the MCU can generate a reset under specific fault conditions. No hardware configuration is required to enable these resets. Refer to the relevant chapters in the *Hardware User's Manual* for details of the conditions that will generate a reset for each peripheral function.

6.8 Determination of Cold/Warm Start

The RA2 MCUs allow the user to determine the cause of the reset processing. The CWSF flag in RSTSR2 indicates whether a power on reset caused the reset processing (cold start) or a reset signal input during operation caused the reset processing (warm start).

The flag is set to 0 when a power on reset occurs. Otherwise, the flag is not set to 0. The flag is set to 1 when 1 is written to it through software. It is not set to 0 even when 0 is written to it.

6.9 Determining the Reset Source

The RA2 MCUs allows the user to determine the reset signal generation source. Read RSTSR0, RSTSR1, and RSTSR2 to determine which reset was the source of the reset. Refer to the *Hardware User's Manual* section, *Determination of Reset Generation Source* for the flow diagram.

The following sample code shows how to determine if a reset is caused by Power On Reset or Software Reset using CMSIS based register structure in Renesas FSP.

```
/* Power on Reset */
if(1 == R_SYSTEM->RSTSR0_b.PORF)
{
    /* Do something */
}

/* Software Reset */
if(1 == R_SYSTEM->RSTSR1_b.SWRF)
{
    /* Do something */
}
```

7. Memory

The RA2 MCUs support a 4 GB linear address space ranging from 0000 0000h to FFFF FFFFh that can contain program, data, and external memory bus. Program and data memory share the address space. Separate buses are used to access each, increasing performance and allowing same-cycle access of program and data. Contained within the memory map are regions for on-chip RAM, peripheral I/O registers, program code flash, and data flash.

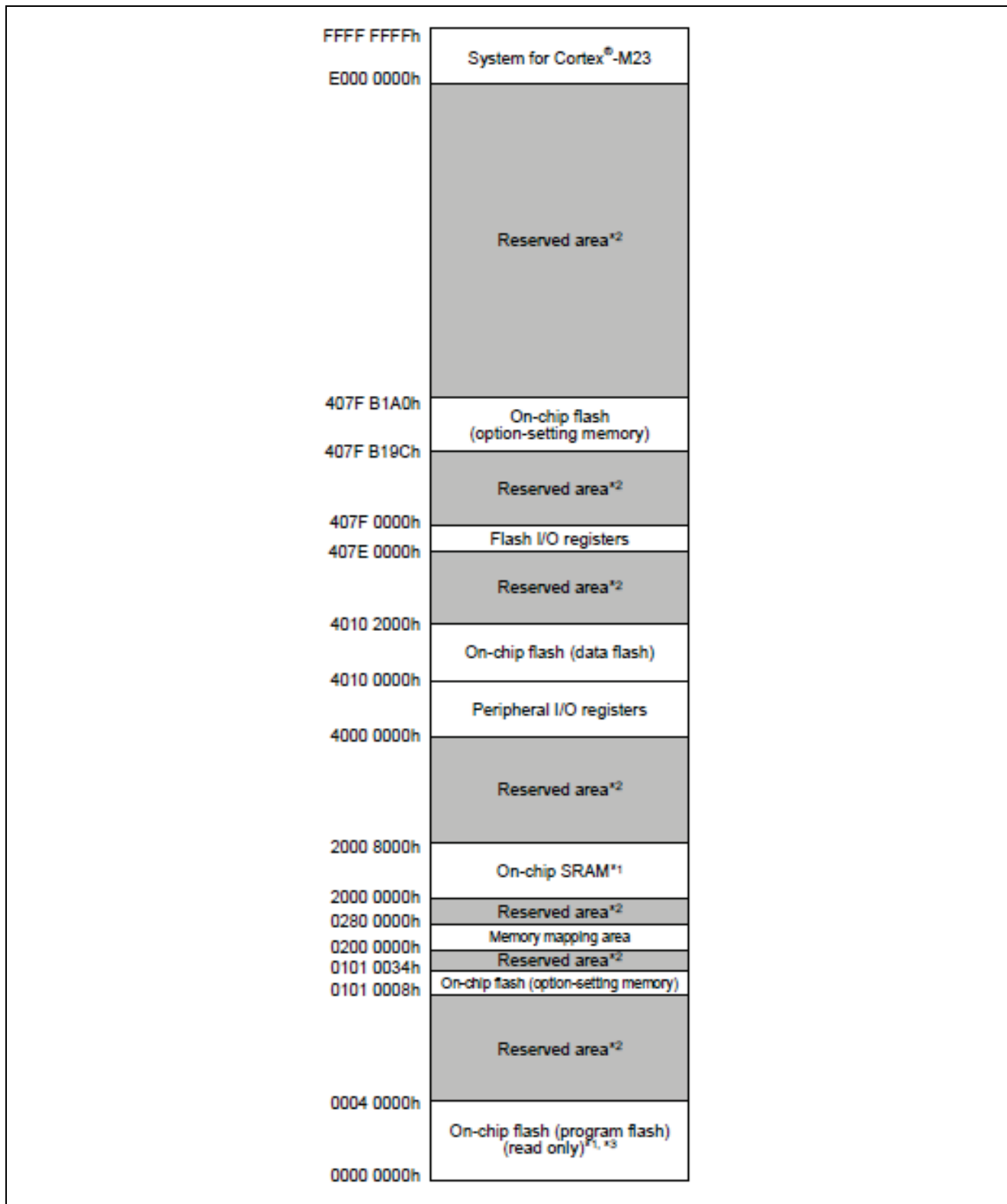


Figure 13. RA2A1 Memory Map

7.1 SRAM

The RA2 MCUs provide on-chip SRAM modules with either parity-bit checking or ECC (Error Correction Code). The following table lists the SRAM specifications for RA2A1 MCU. The SRAM capacity varies by device. Consult the *Hardware User's Manual* for specifics.

Parameter	Specifications without ECC	Specifications with ECC
SRAM capacity	SRAM0: 16 KB	SRAM0 (ECC area): 16 KB
SRAM address	SRAM0: 2000 4000h to 2000 7FFFh	SRAM0 (ECC area): 2000 0000h to 2000 3FFFh
Access*1	0 wait	
Module-stop function	Not available	
Parity	Even parity with 8-bit data and 1-bit parity	No parity
Error checking	Even parity error check	1-bit error correction and up to 2-bit error detection

Figure 14. RA2A1 SRAM Specification

7.2 Peripheral I/O Registers

Blocks of peripheral I/O registers appear at various locations in the memory map depending on the device and the current operating mode. The majority of peripheral I/O registers occupy a region from address 4000 0000h to 400F FFFFh. However, this may vary in location and size by device. Consult the *Hardware User's Manual* for specifics. Details can be found in the appendix, and in the register descriptions for each peripheral function. This region contains registers that are available at all times in all modes of operation. Flash I/O registers to control access flash memory occupy the region from 407E 0000h to 407E FFFFh.

The Renesas FSP contains C header files in CMSIS data structure that map all of the peripheral I/O registers for a specific device to easily accessible I/O data structures.

7.3 On-Chip Flash Memory

The RA2 MCUs feature two flash memory sections: code flash and data flash, which vary in size and programmable cycle capacity by device. The Flash Control Unit (FCU) controls programming and erasure of the flash memory. The Flash Application Command Interface (FACI) controls the FCU in accordance with the specified FACI commands.

The code flash is designed to store user application code and constant data. The data flash is designed to store information that may be updated from time to time such as configuration parameters, user settings, or logged data. The units of programming and erasure in the data flash area are smaller than that of the code flash. For example, on RA2A1 devices, the code flash memory uses 64-bit units for programming and 2 KB units for erasure, while the data flash memory uses 8-bit units for programming and 1 KB units for erasure. The unit sizes vary by device. See the Flash Memory chapter in the *Hardware User's Manual* for details.

Both the data flash and code flash areas can be programmed or erased by application code. This enables field firmware updates without having to connect an external programming tool.

Renesas FSP provides HAL layer drivers for both code flash memory and data flash memory.

The following figure shows example specifications of code flash memory and data flash memory.

Parameter	Code flash memory	Data flash memory
Memory capacity	<ul style="list-style-type: none"> 256 KB of user area 	8 KB of data area
Read cycle	<ul style="list-style-type: none"> 32 MHz < ICLK frequency ≤ 48 MHz Cache hit: 1 cycle Cache miss: 2, 3 cycles ICLK frequency ≤ 32 MHz Cache hit: 1 cycle Cache miss: 1 cycle. 	A read operation takes 6 FCLK cycles in bytes (FCLK frequency ≤ 32 MHz)
Value after erasure	FFh	FFh
Programming/erasing method	<ul style="list-style-type: none"> Programming and erasure of code and data flash memory through the FCB commands specified in the registers Programming by dedicated flash-memory programmer through a serial interface (serial programming) Programming of flash memory by user program (self-programming). 	
Security function	Protection against illicit tampering with or reading of data in flash memory	
Protection	Protection against erroneous overwriting of flash memory	
Background operations (BGOs)	Code flash memory can be read during data flash memory programming	
Units of programming and erasure	<ul style="list-style-type: none"> 64-bit units for programming in user area 2-KB units for erasure in user area. 	<ul style="list-style-type: none"> 8-bit units for programming in data area 1-KB units for erasure in data area.
Other functions	Interrupts accepted during self-programming	
	An expansion area of flash memory (option bytes) can be set in the initial MCU settings	
On-board programming	<p>Programming in serial programming mode (SCI boot mode):</p> <ul style="list-style-type: none"> Asynchronous serial interface (SCI9) used Transfer rate adjusted automatically. <p>Programming in serial programming mode (USB boot mode*1):</p> <ul style="list-style-type: none"> USBFS used Dedicated hardware not required, so direct connection to a PC is possible. <p>Programming in on-chip debug mode:</p> <ul style="list-style-type: none"> SWD interface used Dedicated hardware not required. <p>Programming by a routine for code and data flash memory programming within the user program:</p> <ul style="list-style-type: none"> Allows code and data flash memory programming without resetting the system. 	

Figure 15. Specifications of Code Flash Memory and Data Flash Memory on RA2A1 MCU

Note: Erase state of code flash is FFh but erase state of data flash is undefined.

7.3.1 Background Operation

RA2 MCUs support background operations for code flash and data flash. This means that when a program or erase starts, the user can keep executing and accessing memory from memory areas other than the one being operated on. For example, the CPU can execute application code from code flash while the data flash memory is being erased or programmed. Also, the CPU can execute application code from SRAM while the code flash memory is being erased or programmed. The only exception to this rule is that the data flash cannot be accessed during code flash programming or erasing.

7.3.2 ID Code Protection

RA2 MCUs have a 128-bit memory in option setting memory area that is used as an ID code. If this ID code is left blank (0xFF's) then no protection is enabled and access to the MCU is allowed through boot mode or using the on-chip debugger. If the ID code is set, then the user can control access to these modes. The user can choose to always disallow connections or can choose to allow connections when a matching ID code is input. Refer to the OCD/Serial Programmer ID Setting Register (OSIS) and ID Code Protection and sections of *RA2 MCU Hardware User's Manual* for more information.

Renesas FSP configurator provides options to set up ID code protection for RA2 MCUs as shown in Figure 16.

Settings	Property	Value
	> R7FA2A1AB3CFM	
	> RA2A1	
	▼ RA2A1 Family	
	> OFS0 register settings	
	> OFS1 register settings	
	> MPU	
	Use Low Voltage Mode	Disabled
	Main Oscillator Wait Time	262144 cycles
	ID Code Mode	Unlocked (Ignore ID)
	ID Code (32 Hex Characters)	FFFFFFFFFFFFFFFFFFFFFFFFFFFFFFFF
	> RA Common	

Figure 16. ID Code Setup for RA2A1 Using Renesas FSP Configurator

Note: ID code protection settings must be handled carefully to prevent mistakes that may result in blocking access to the MCU.

7.3.3 Memory Protection Unit

RA2 MCUs have a Memory Protection Unit (MPU). The MPU can protect various MCU regions from illegal access. The choices include allowing both reading and writing, prohibiting writing, and prohibiting writing and reading. Select one of these options by setting the corresponding constant value at the specific memory address. See *Memory Protection Unit* in the *MCU Hardware User's Manual* for more details.

Settings	Property	Value
	> R7FA2A1AB3CFM	
	> RA2A1	
	▼ RA2A1 Family	
	> OFS0 register settings	
	> OFS1 register settings	
	▼ MPU	
	Enable or disable PC Region 0	Disabled
	PC0 Start	0x000FFFFC
	PC0 End	0x000FFFFF
	Enable or disable PC Region 1	Disabled
	PC1 Start	0x000FFFFC
	PC1 End	0x000FFFFF
	Enable or disable Memory Region 0	Disabled
	Memory Region 0 Start	0x000FFFFC
	Memory Region 0 End	0x000FFFFF
	Enable or disable Memory Region 1	Disabled
	Memory Region 1 Start	0x200FFFFC
	Memory Region 1 End	0x200FFFFF
	Enable or disable Memory Region 2	Disabled
	Memory Region 2 Start	0x407FFFFC
	Memory Region 2 End	0x407FFFFF
	Enable or disable Memory Region 3	Disabled
	Memory Region 3 Start	0x400DFFFC
	Memory Region 3 End	0x400DFFFF
	Use Low Voltage Mode	Disabled
	Main Oscillator Wait Time	262144 cycles
	ID Code Mode	Unlocked (Ignore ID)
	ID Code (32 Hex Characters)	FFFFFFFFFFFFFFFFFFFFFFFFFFFFFFFF
	> RA Common	

Figure 17. MPU Setup for RA2A1 Using Renesas FSP Configurator

Note: MPU settings must be handled carefully to prevent mistakes that may result in blocking accesses to an MCU region.

7.4 Restriction on Endianness

Memory space must be little-endian to execute code on the Arm® Cortex®-M core.

8. Register Write Protection

The register write protection function protects important registers from being overwritten because of software errors. The registers to be protected are set with the Protect Register (PRCR). Table 9 lists the association between the PRCR bits and the registers to be protected.

b15	b14	b13	b12	b11	b10	b9	b8	b7	b6	b5	b4	b3	b2	b1	b0
PRKEY[7:0]								—	—	—	—	PRC3	—	PRC1	PRC0

Figure 18. PRCR Register

Table 9. PRCR Protection Bits

PRCR bit	Description
PRC0	Registers related to the Clock Generation Circuit: SCKDIVCR, SCKSCR, MEMWAIT, MOSCCR, HOCOCR, MOCOCR, CKOCR, OSTDCR, OSTDSR, MOCOUTCR, HOCOUTCR, MOSCWTCR, MOMCR, SOSCCR, SOMCR, LOCOCR, LOCOUTCR, HOCOWTCR, SOMRG, SDADCCKCR, LPOPT
PRC1	Registers related to the low power modes: SBYCR, SNZCR, SNZEDCR, SNZEDCR0, SNZREQCR, FLSTOP, OPCCR, SOPCCR, SYOCDCR, PSMCR, DCDCTL, VCCSEL
PRC3	8.1.1 Registers related to the LVD: LVD1CR1, LVD1SR, LVD2CR1, LVD2SR, LVCMPCCR, LVDLVLR, LVD1CR0, LVD2CR0
PRKEY[7:0]	These bits control write access to the PRCR register. To modify the PRCR register, write A5h to the eight higher-order bits and the wanted value to the eight lower-order bits as a 16-bit unit.

Note: Not all registers may be included on all RA2 devices. Please refer to the *Register Write Protection* section of the *Hardware User's Manual* for more details.

Renesas FSP supplies two APIs (`R_BSP_RegisterProtectEnable` and `R_BSP_RegisterProtectDisable`) to enable and disable Register Write Protection, respectively.

9. I/O Port Configuration

The *I/O Ports* section of the *Hardware User's Manual* describes exact pin configurations based on peripheral selection and other register settings. Some general information is listed as follows.

It is important to note that after a reset, each pin will be in the default state for that pin until the configuration is applied. For RA2 devices, all I/O pins operate as input pins immediately after a reset. There may be a small period where some pins may be in an undesirable state. This will be true regardless of what configuration approach is used. The user should consider the impact this may have for each application, including how this may affect other system features.

The IO Port Configuration may be set by either directly writing to registers or using the FSP Pin Configurator.

9.1 Multifunction Pin Selection Design Strategies

Most ports on the RA2 Series of MCUs can have multiple peripheral functions. Tools, such as the Pin Configurator in FSP, are available from Renesas to assist with port selection for each RA2 device. When several peripheral functions are needed, use the following design strategies to help with port function selection.

- Assign peripheral functions with only one port option first. For example, there is only one port option for each debug signal in the debug function. When this function is needed, assign these ports first.
- Assign peripheral functions with limited port options next. For example, the CLKOUT function typically only has two options for the CLKOUT signal.
- Assign peripheral functions with multiple port options last. One example would be the Serial Communications Interface (SCI) which typically has many available port options.
- The Pin Lists section in the RA2 *Hardware User's Manuals* show some peripheral port functions with a suffix (such as “_A”) at the end of the function name. For RA2 devices, this type of suffix can be ignored when assigning port functions. Also see section 16.3 in this document.

9.2 Setting Up and Using a Port as GPIO

There are two methods for setting up and using a port as GPIO, either using the Port Control Register (PCNTR1), or the PmnPFS registers.

Method 1: Port Control Register (PCNTR1)

- Select a pin as an output by writing a 1 to the Port Direction bit (PDRn) in Port Control Register 1 (PCNTR1).
- The Port Direction bits (PDRn) are read/write. Setting the value to a 1 selects the pin as an output. Default state for I/O Ports is 0 (input). The port direction registers can be read on the RA2 MCUs.
- The Port Output Data bits (PODRn) in the corresponding Port Control Register (PCNTR1) are read/write. When the PODR is read the state of the output data latch (not the pin level) is read.
- The Port Input bits (PIDRn) in Port Control Register 2 (PCNTR2) are read only. Read the PIDRn bit in the PCNTR2 register to read the pin state.

Method 2: Port mn Pin Function Select (PmnPFS) Registers

- The Port Mode Register (PMR) is read/write. It is used to specify whether individual pins function as GPIO or as peripheral pins. Out of reset, all PMR registers are set to 0 which sets all pins to work as GPIO. If a PMR register is set to 1 then that corresponding pin will be used for peripheral functions. The peripheral function is defined by that pin's MPC setting.
- When setting a pin as an output, it is recommended that the desired output value of the port be written to the data latch first, then the direction register should be set to an output. Though not important in all systems, this prevents an unintended output glitch when the port is set up.

In general, using PCNTR1 to configure a port will provide faster access but will have fewer configuration features available. Using the PmnPFS registers will have more configuration features available but will have slower access.

Renesas FSP provides a Pin Configurator to configure the GPIO pin after reset as shown in Figure 19. After the GPIO is configured, it can be controlled using HAL layer APIs in FSP.

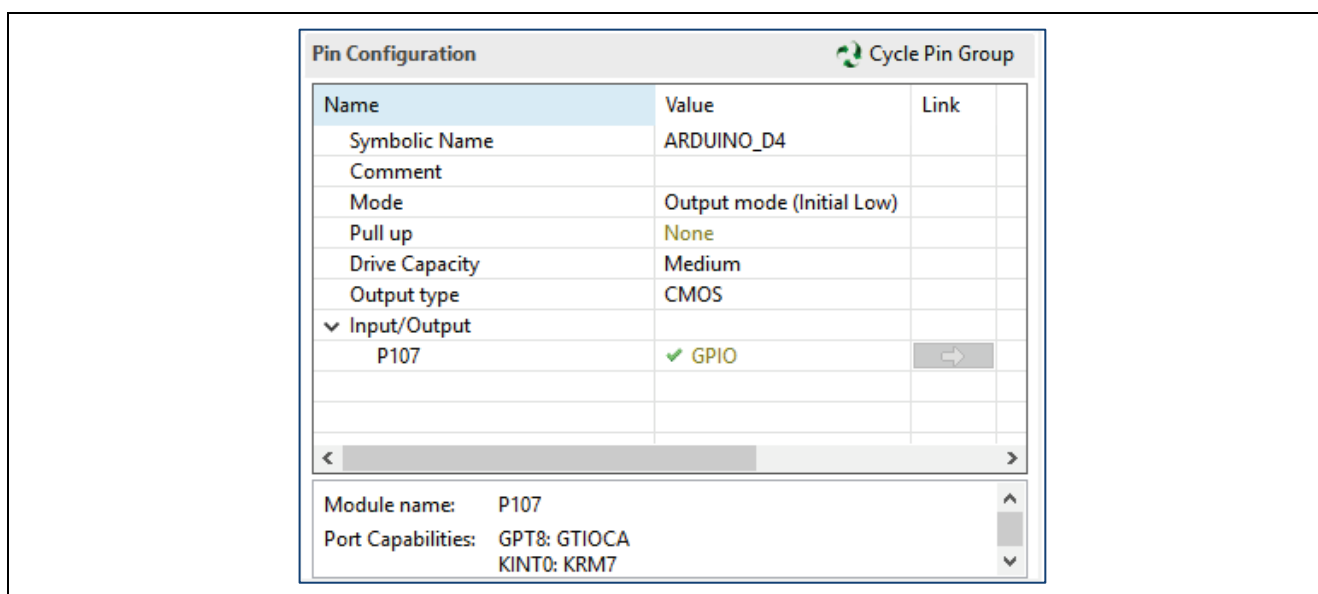


Figure 19. Configuring P107 as Output and Low using FSP Configurator

9.2.1 Internal Pull-Ups

- Most pins on ports 0 through 9 can enable a pull-up resistor. The pull-up is controlled by the Pull-Up bit (PCR) bit in each Port mn Pin Function Select (PmnPFS) register. The PCR bit in each PmnPFS register controls the corresponding pin on the port.
- The pin must first be set as an input with the associated bit in the PmnPFS register. Set the PCR bit to 1 to enable the pull-up and to 0 to disable it.
- Out of reset all PCR registers are cleared to 0, therefore all pull-up resistors are disabled.
- The pull-up is automatically turned off whenever a pin is designated as an external bus pin, a GPIO output, or a peripheral function output pin.

9.2.2 Open-Drain Output

- Pins configured as outputs normally operate as CMOS outputs.
- Most pins on ports 0 through 9 can be configured as an NMOS open-drain output.
- The N-channel open-drain control (NCODR) bit in each Port mn Pin Function Select (PmnPFS) Register controls which pins operate in open-drain mode. Setting the applicable bit in each register to a 1 makes the output open-drain. Setting the applicable bit in each register to a 0 sets the port to CMOS output.

9.2.3 Drive Capacity

The RA2A1 MCU group can enable an output drive capacity. For RA2A1, the drive capacity can be set to low- or middle-drive capacity. The other RA2 MCU groups do not have this capability.

- Drive capacity switching is controlled by the Drive Capacity Control Register (DSCR) bits in each Port mn Pin Function Select (PmnPFS) register.
- Out of reset, all DSCR registers are cleared to 0. Therefore, all pins are set to low drive output. Setting a value other than 00 will change the drive capacity of the output for the selected pin.
- The maximum total output of all pins is dependent on the specific MCU group and device package. Please see the Electrical Characteristics" section of the Hardware User's Manual for details.
- The typical differences the drive levels are shown below. Actual output current levels vary by device and pin type. See the specific MCU Hardware User's Manual for details.

Table 10. Differences in Drive Levels

Typical Output Pins	DSCR[1:0]	Drive Capacity	Max (mA)
Permissible output current per pin	0 0	Low Drive	4.0
Permissible output current per pin	0 1	Middle Drive	8.0
IIC Fast Mode and SPI	1 0	Middle Drive	8.0
Invalid setting; do not use	1 1	--	

Output drive capacity can have a significant impact on overall performance of a board design. The following points should be considered when selecting the drive capacity for each output.

- It is recommended to start with all pins set to low-drive capacity (default) and evaluate the performance.
- Depending on the board layout, pins set to middle-drive capacity may result in higher EMI radiation.
- Long traces may require higher drive capacity for signals to propagate correctly to the receiver.

9.3 Setting Up and Using Port Peripheral Functions

The Port *mn* Pin Function Select Registers (PmnPFS) are used to configure the characteristics of each port. The PSEL bits select the peripheral function selected for each port.

- Since most pins have multiple functions, the RA2 MCUs have Pin Function Control Registers (PmnPFS) that allow you to change the function assigned to a pin.
- Each pin has its own PmnPFS register.
- Each PmnPFS register allows a pin to be used for peripheral function (PSEL bits), as an IRQ input pin (ISEL bit), or as an analog input pin (ASEL bit). If the ASEL bit is set to 1 (use pin as analog input pin) then the pin's PMR bit should be set for GPIO use and the pin's PDR bit should be set for input.
- Refer to the Peripheral Select Settings for each Product section in the I/O Ports chapter of the Hardware User's Manual.
- In order to ensure that no unexpected edges are input or output on peripheral pins, make sure to clear the Port Mode Control (PMR) bit for the targeted pin before modifying the pin's PmnPFS register.
- All PmnPFS registers are write protected out of reset. In order to write to these registers, first enable writing using the Write-Protect Register (PWPR).
- Care should be taken when setting PmnPFS registers so that a single function is not assigned to multiple pins. The user should not do this, but the MCU will allow it. If this occurs the function on the pins will be undefined.

Figure 20 shows an example of enabling SPI0 pins using FSP Pin configuration.

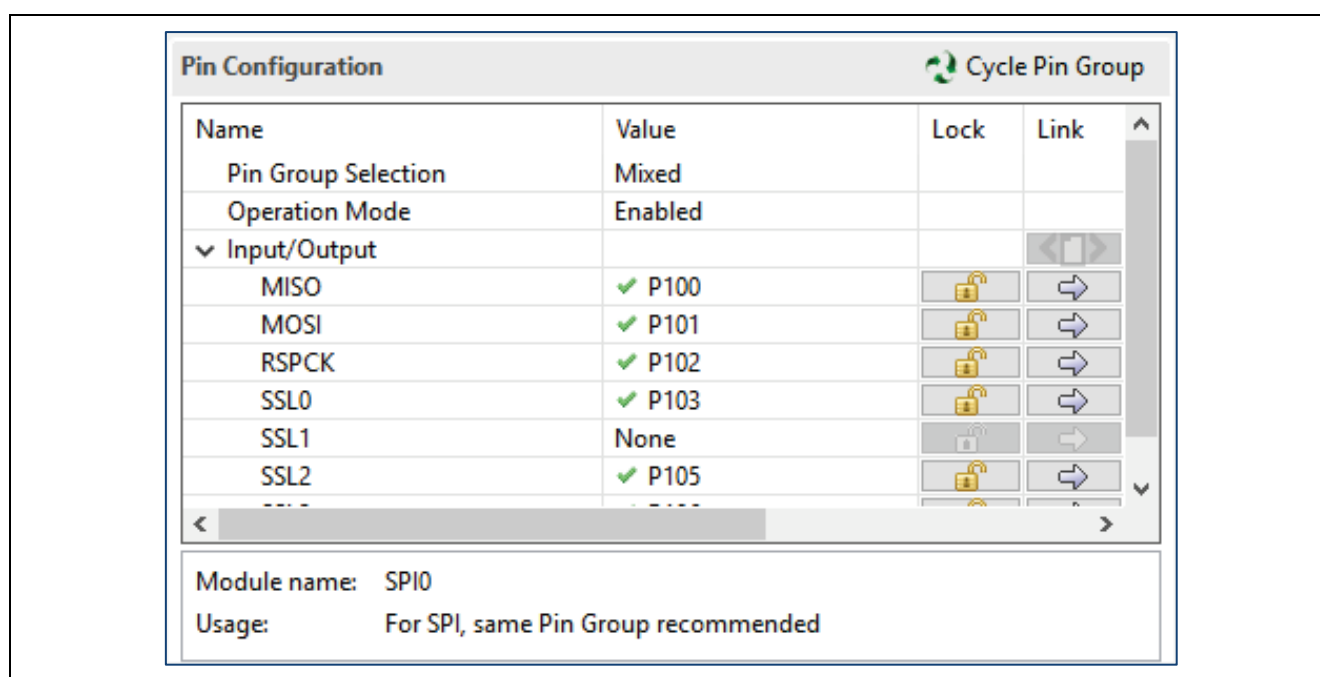


Figure 20. Enabling SPI0 pins Using Pin Configurator in Renesas FSP

9.4 Setting Up and Using IRQ Pins

- Certain port pins can be used as hardware interrupt lines (IRQ). See the Peripheral Select Settings for each Product section in the I/O Ports chapter of the Hardware User's Manual for information on which pins are available for your MCU.
- To set a port pin to be used as an IRQ pin, the Interrupt Input Function Select bit (ISEL) in the pin's PFS register must be set to 1.
- Pins can be used for both IRQ and peripheral functions simultaneously. To enable this, set both the ISEL and PSEL bits in the pin's PFS register.
- IRQ functions of the same number must only be enabled on one pin.
- IRQ pins can trigger interrupts on detection of:
 - Low level
 - Falling edge
 - Rising edge
 - Rising and falling edges

The IRQ Control Registers (IRQCRi) controls which trigger is selected.

- Digital filtering is available for IRQ pins. The filters are based on repetitive sampling of the signal at one of four selectable clock rates (PCLKB, PCLKB/8, PCLKB/32, PCLKB/64). This filters out short pulses: any high or low pulse less than 3 samples at the filter rate. The filters are useful for filtering out ringing and noise in these lines but are much too quick for filtering out long events like mechanical switch bounce. Enabling filtering adds a short bit of latency (the filter time) to the hardware IRQ lines.
- Digital filtering can be enabled for each IRQ pin independently. This is done by setting the IRQ Pin Digital Filter Enable (FLTEN) bit in the IRQCRi register for each IRQ.
- The clock rate for digital filtering is configurable for each IRQ pin independently. This is done by setting the IRQ Pin Digital Filter Setting (FCLKSEL[1:0]) bits in the IRQCRi register for each IRQ.

Figure 21 and Figure 22 show examples of enabling and configuring IRQ pins using Renesas FSP.

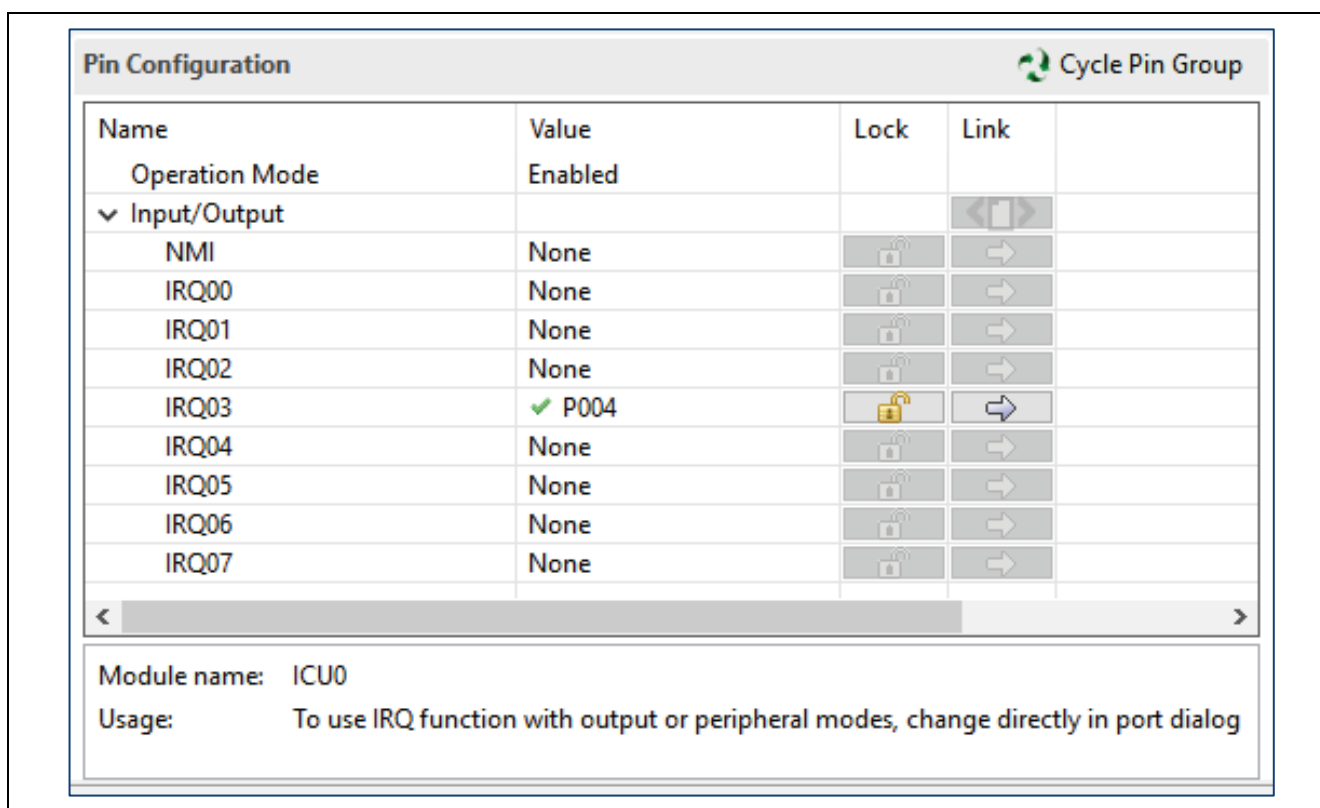


Figure 21. Enable P004 as IRQ03 Input Using Pin Configurator in Renesas FSP

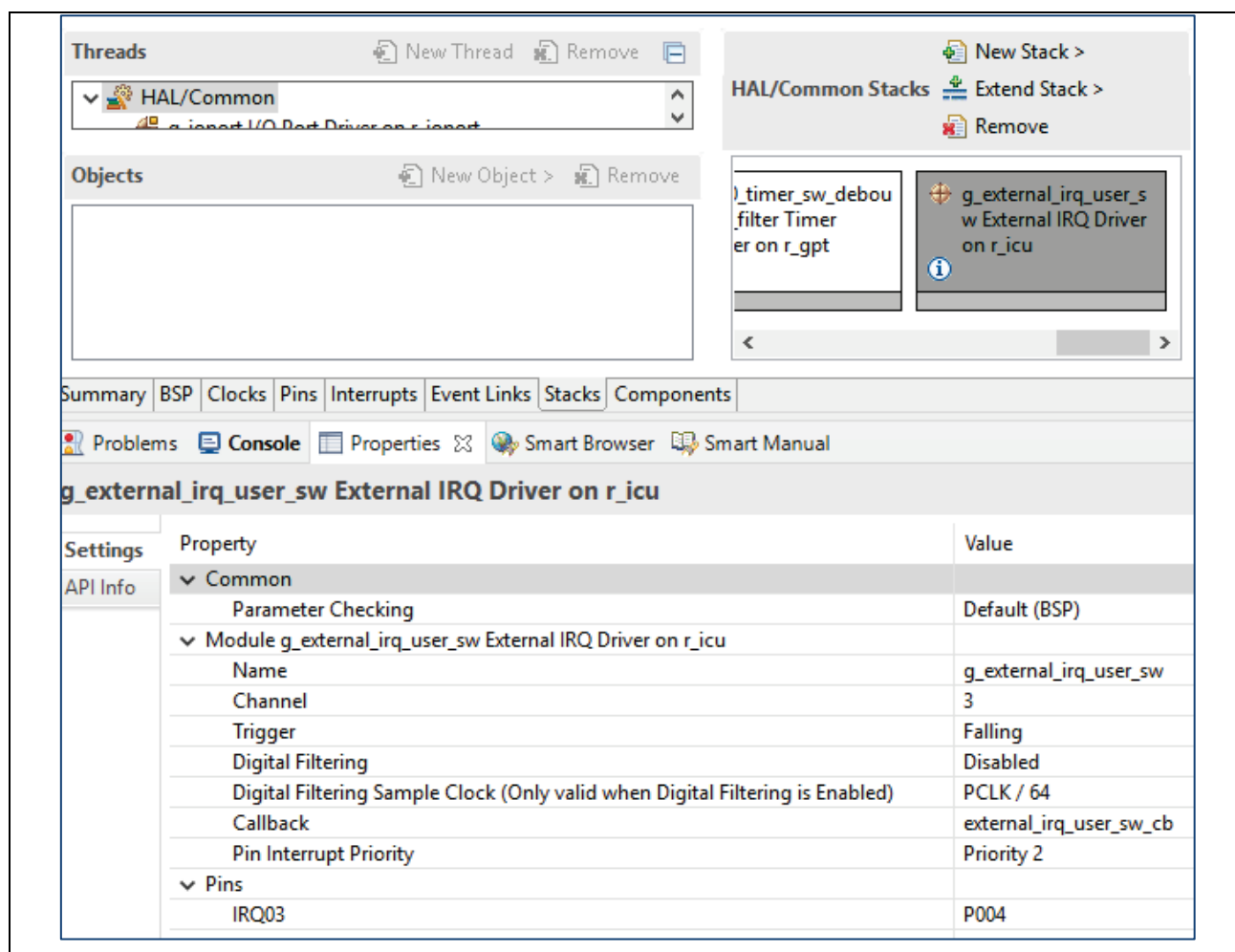


Figure 22. Configure IRQ03 Using Renesas FSP Configurator

9.5 Unused Pins

Note: Some pins require specific termination: See the *Handling of Unused Pins* section of the *Hardware User's Manual* for specific recommendations.

Unused pins that are left floating can consume extra power and leave the system more susceptible to noise problems. Terminate unused pins with one of the methods detailed here:

1. The first option is to set the pin to an input (the default state after reset) and connect the pin to VCC or VSS using a resistor. There is no difference to the MCU between one connection or another; however, there may be an advantage from a system noise perspective. VSS is probably the most typical choice. Avoid connecting a pin directly to VCC or VSS since an accidental write to the port's direction register that sets the pin to an output could create a shorted output.
2. A second method is to set the pin to an output. The pin level may be set high or low. However, setting the pin as an output and making the output low connects the pin internally to the ground plane. This may help with overall system noise concerns. A disadvantage of setting unused pins to outputs is that the configuration of the port must be done via software control. While the MCU is held in reset and until the direction register is set for output, the pin will be a floating input and may draw extra current. If the extra current can be tolerated during this time, this method eliminates the external resistors required in the first method.
3. A variation on leaving the pins as inputs and terminating them with external resistors uses the internal pull-ups available on many ports of the MCU. This has the same limitation as setting the pins to outputs (requires the program to set up the port) but it does limit the effect of accidental pin shorts to ground, adjacent pins or VCC since the device will not be driving the pin.

9.6 Nonexistent Pins

Each RA2 MCU group is available in multiple package sizes, with different total pin counts. For any package smaller than the largest package for that MCU group (typically 100 pins, 64 pins, or 24 pins), set the corresponding bits of nonexistent ports in the PDR register to 0 and in the PODR register to 0. The user can see which ports are available on each MCU package by reviewing the Specifications of I/O Ports table in the I/O Ports section of the Hardware User's Manual. For example, P007 and P008 on port 0 are only available on 100-pin packages. Note that no additional handling of nonexistent pins is required.

9.7 Electrical Characteristics

Normal GPIO ports typically require CMOS level inputs ($\text{High} \geq 0.8 * V_{CC}$, $\text{Low} \leq 0.2 * V_{CC}$). Some GPIO ports have Schmitt Trigger inputs, which have slightly different input requirements. See the *Hardware User's Manual* section *Electrical Characteristics* for more information.

10. Module Stop Function

To maximize power efficiency, the RA2 series of MCUs allow on-chip peripherals to be stopped individually by writing to the Module Stop Control Registers (MSTPCR_i, $i=A, B, C, D$). Once a module stops, access to the module registers is not possible.

After a reset, most of the modules are placed in module-stop state, except for DTC. See *Hardware User's Manual* for details.

Before accessing any of the registers for a peripheral, the peripheral must be enabled by taking it out of stop mode by writing a 0 to the corresponding bit in the MSTPCR_i register.

Peripherals may be stopped by writing a 1 to the proper bit in the MSTPCR_i register.

HAL drivers in Renesas FSP handle module start/stop function automatically.

11. Interrupt Control Unit

The Interrupt Controller Unit (ICU) controls which event signals are linked to the Nested Vector Interrupt Controller (NVIC) and Data Transfer Control (DTC) modules. The ICU also controls non-maskable interrupts. Figure 23 shows an example of the ICU specifications, and Figure 24 shows an example of the ability to raise the IRQi event from the I/O pins. Refer to the *Hardware User's Manual* for details for each RA2 MCU Group.

Parameter	Specifications	
Interrupts	Peripheral function interrupts	<ul style="list-style-type: none"> Interrupts from peripheral modules Number of sources: 132 (select factor within event list numbers 9 to 141)
	External pin interrupts	<ul style="list-style-type: none"> Interrupt detection on low level^{*4}, falling edge, rising edge, rising and falling edges. One of these detection methods can be set for each source. Digital filter function supported 8 sources, with interrupts from IRQ0 to IRQ7 pins.
	DTC control	The DTC can be activated by interrupt sources ^{*1}
	Interrupt sources for NVIC	32 sources
Non-maskable interrupts ^{*2}	NMI pin interrupt	<ul style="list-style-type: none"> Interrupt from the NMI pin Interrupt detection on falling edge or rising edge Digital filter function supported.
	Oscillation stop detection interrupt ^{*3}	Interrupt on detecting that the main oscillation has stopped
	WDT underflow/refresh error ^{*3}	Interrupt on an underflow of the down-counter or occurrence of a refresh error
	IWDT underflow/refresh error ^{*3}	Interrupt on an underflow of the down-counter or occurrence of a refresh error
	Voltage monitor 1 interrupt ^{*3}	Voltage monitor interrupt of low voltage detection 1 (LVD_LVD1)
	Voltage monitor 2 interrupt ^{*3}	Voltage monitor interrupt of low voltage detection 2 (LVD_LVD2)
	RPEST	Interrupt on SRAM parity error
	RECCST	Interrupt on SRAM ECC error
	BUSST	Interrupt on MPU bus slave error
	BUSMST	Interrupt on MPU bus master error
	SPEST	Interrupt on CPU stack pointer monitor
Return from low power mode		<ul style="list-style-type: none"> Sleep mode: return is initiated by non-maskable interrupts or any other interrupt source Software Standby mode: return is initiated by non-maskable interrupts. Interrupt can be selected in the WUPEN register^{*5}. Snooze mode: return is initiated by non-maskable interrupts. Interrupt can be selected with the SELSR0 and WUPEN registers^{*5}.

Figure 23. RA2A1 ICU Specifications

Pin name	I/O	Description
NMI	Input	Non-maskable interrupt request pin
IRQ0 to IRQ7	Input	External interrupt request pins

Figure 24. RA2A1 ICU I/O Pins

Figure 25 is an example of using a Renesas FSP configurator to enable and configure an interrupt using Renesas FSP. The ICU and interrupts are configured as part of the HAL driver configuration through FSP.

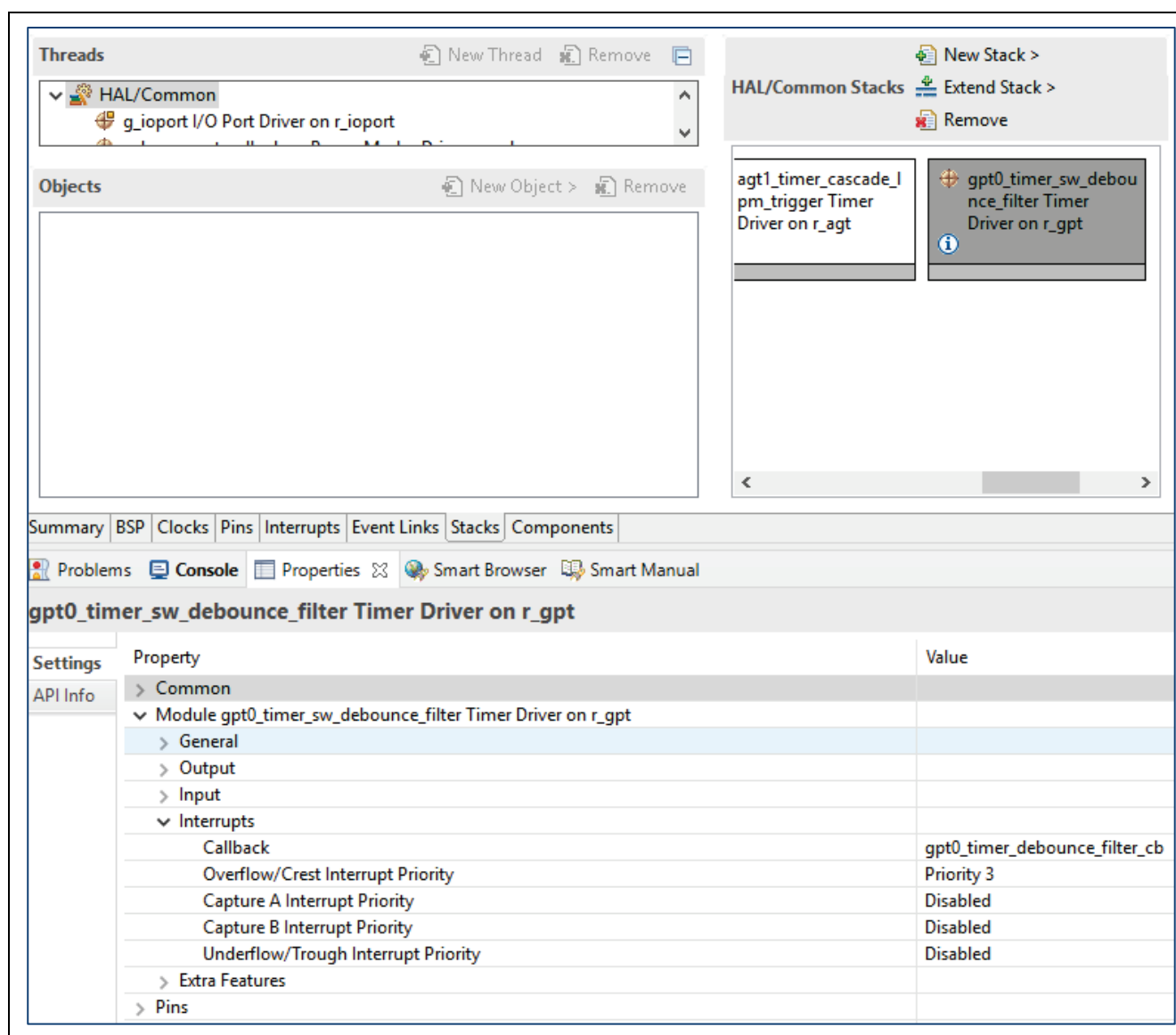


Figure 25. Enable GTP0 Overflow Interrupt and Set User Callback Functions Invoked by Interrupt Service Routine

12. Low Power Consumption

The RA2 devices have several functions for reducing power consumption. These include setting clock dividers, stopping modules, selecting power control mode in Normal mode, and transitions to low power modes. Refer to the Low Power Modes chapter in the *Hardware User's Manual* for more details.

RA2 MCUs support three different types of LPM. These are:

- Sleep mode
- Software Standby mode
- Snooze mode

The following table is an overview of the functions available for reducing power consumption.

Table 11. Specifications of Low Power Mode Functions

Item	Specification
Reducing power consumption by modifying clock signals	The frequency division ratio can be selected independently for the system clock (ICLK), peripheral module clock (PCLKB, PCLKD, CLKOUT), and flash interface clock (FCLK). ^{*1}
Module stop	Functions can be stopped independently for each peripheral module.
Low power modes	<ul style="list-style-type: none"> • Sleep mode • Software Standby mode • Snooze mode
Power control modes	Operating power control modes: <ul style="list-style-type: none"> • High-speed mode • Middle-speed mode • Low-speed mode • Low-voltage mode^{*2} • Subosc-speed mode

Notes: 1. For details, see the chapter *Clock Generation Circuit* in the *Hardware User's Manual*.

2. Only RA2A1 group supports low-voltage mode.

RA2L1 MCU group devices can be operated in switch regulator (DCDC) mode. In DCDC mode, only Normal mode and Sleep mode can be supported. The system cannot transition to Software Standby mode or Snooze mode while in DCDC mode.

Additionally, RA2L1 devices in LDO mode and either low-speed mode or Subosc-speed mode cannot transition to DCDC mode. In DCDC mode, only high-speed mode and middle-speed mode are supported.

Table 12 lists the conditions to transition to low power modes, the states of the CPU and the peripheral modules, and the method for cancelling each mode.

Table 12. Low Power Consumption Modes

State of operation ^{*1}	Sleep Mode	All-Module Clock Stop Mode	Software Standby Mode
Transition condition	WFI instruction while SBYCR.SSBY=0	WFI instruction while SBYCR.SSBY=1 and DPSBYCR.DPSBY=0	Snooze request trigger in Software Standby mode. SNZCR.SNZE=1
Canceling method	All interrupts. Any reset available in the mode.	Interrupts defined for this mode. Any reset available in the mode.	Interrupts defined for this mode. Any reset available in the mode.
State after cancellation by an interrupt	Program execution state (interrupt processing)	Program execution state (interrupt processing)	Program execution state (interrupt processing)
State after cancellation by a reset	Reset state	Reset state	Reset state

Notes: 1. Refer to the table Operating Conditions of Each Low Power Mode in the *Hardware User's Manual* for additional details.

RA2 devices include register settings that allow the MCU to operate with lower power consumption in Normal mode and Sleep mode. These modes are referred to as the Operating Power Control Modes and are controlled by the OPCCR register.

The following is a summary of the Operating Power Consumption Control modes and the maximum permissible clocking and voltage levels under each mode.

Table 13. Available Oscillators in Each Operating Power Consumption Control Mode

Mode	Oscillator						
	High-speed on-chip oscillator	Middle-speed on-chip oscillator		Low-speed on-chip oscillator	Main clock oscillator*2	Sub-clock oscillator*2	IWDT-dedicated on-chip oscillator
High-speed	Available	Available		Available	Available	Available	Available
Middle-speed	Available	Available	Available	Available	Available	Available	
Low-speed	Available	Available		Available	Available	Available	Available
Low-voltage*1		Available	Available	Available	Available	Available	Available
Subosc-speed	N/A	N/A		Available	N/A	Available	Available

Notes 1: Only RA2A1 group supports low-voltage mode.

2: Not present on RA2E2

While it may be possible to set the value in the OPCCR register to any of the low power operating modes, clocking and voltage levels must also be set to meet the requirements of the desired mode. Otherwise, the settings in the OPCCR register will not have any effect in lowering power consumption.

In order to achieve the lowest power numbers, use the maximum possible dividers in the clock generation circuits.

Low power modes are canceled by various interrupt sources such as RES pin reset, power-on reset, voltage monitor reset, and peripheral interrupts. Refer to the Low Power Modes section in the *Hardware User's Manual* for a list of interrupt sources for different LPMs.

Only Snooze mode is triggered by a Snooze request to enter snooze mode from Software Standby mode. The transitions to other LPMs are done by executing a WFI instruction with appropriate settings in the Standby Control register (SBYCR).

Renesas FSP provides a low power mode (LPM) driver and driver configurator to set up low power mode, wake source/cancel source, and so forth.

g_lpm_sw_standby Low Power Modes Driver on r_lpm		
Settings	Property	Value
API Info	> Common	
	▼ Module g_lpm_sw_standby Low Power Modes Driver on r_lpm	
	▼ General	
	Name	g_lpm_sw_standby
	Low Power Mode	Software Standby mode
	Output port state in standby and deep standby	Not Available
	▼ Standby Options	
	> Wake Sources	
	> Snooze End Sources	
	Snooze Request Source	RXD0 falling edge
	DTC state in Snooze Mode	Disabled
	Snooze Cancel Source	None
	> Deep Standby Options	

Figure 26. Set Up Low Power Mode Using Renesas FSP Configurator

After a specific LPM mode is set up by the FSP Configurator, the LPM driver's API can be used to initialize LPM driver and place MCU in configured LPM mode, as shown in the following example:

```
/* Open LPM driver and initialize LPM mode */
err = R_LPM_Open(&g_lpm_sw_standby_ctrl, &g_lpm_sw_standby_cfg);
/* Handle error */
if (FSP_SUCCESS != err)
{
    return (err);
}
/* Transition to configured LPM mode: Deep Software Standby Mode */
err = R_LPM_LowPowerModeEnter(&g_lpm_sw_standby_ctrl);
/* Handle error */
if (FSP_SUCCESS != err)
{
    return (err);
}
```

13. Buses

The buses in RA2 MCUs consist of a main bus and a slave interface. Figure 27 lists the main bus and the slave interface. Figure 28 shows the bus configuration.

Note: Memory space must be little-endian in order to execute Arm® Cortex® code.

Bus type		Specifications
Main bus	System bus (CPU)	<ul style="list-style-type: none"> Connected to CPU Connected to on-chip memory and internal peripheral bus.
	DMA bus	<ul style="list-style-type: none"> Connected to DTC Connected to on-chip memory and internal peripheral bus.
Slave Interface	Memory bus 1	<ul style="list-style-type: none"> Connected to code flash memory
	Memory bus 3	<ul style="list-style-type: none"> Connected to code flash memory by DMA bus
	Memory bus 4	<ul style="list-style-type: none"> Connected to SRAM0
	Internal peripheral bus 1	<ul style="list-style-type: none"> Connected to system control related to peripheral modules
	Internal peripheral bus 3	<ul style="list-style-type: none"> Connected to peripheral modules (CAC, ELC, I/O Ports, POEG, RTC, WDT, IWDG, IIC, CAN, ADC16, DAC12, DOC, GPT, SCI, SPI, and CRC)
	Internal peripheral bus 5	<ul style="list-style-type: none"> Connected to peripheral modules (KINT, AGT, USBFS, DAC8, OPAMP, ACMPHS, ACMPLP, SDADC24, and CTSU)
	Internal peripheral bus 7	<ul style="list-style-type: none"> Connected to Secure IPs
	Internal peripheral bus 9	<ul style="list-style-type: none"> Connected to flash memory (in P/E) and data flash memory

Figure 27. RA2A1 Bus Specifications

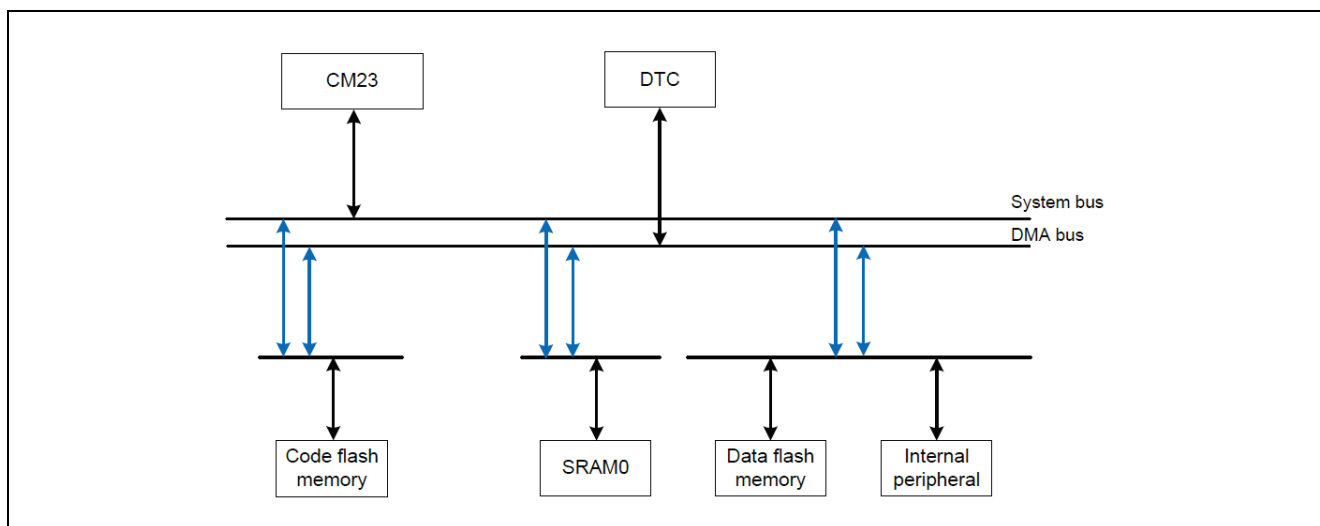


Figure 28. RA2 MCU Bus Configuration

13.1 Bus Error Monitoring

The monitoring system monitors each individual area. Whenever it detects an error, it returns the error to the requesting master IP using the AHB-Lite error response protocol.

13.1.1 Bus Error Types

The following types of errors can occur on each bus:

- Illegal address access
- Bus master MPU error
- Bus slave MPU error
- Timeout

13.1.2 Operation When a Bus Error Occurs

When a bus error occurs, operation is not guaranteed, and the error is returned to the requesting master IP. The bus error information that occurred in each master is stored in the BUSnERRADD and BUSnERRSTAT registers. These registers must be cleared by reset only. For more information, see the Bus Error Address Register (BUSnERRADD) and Bus Error Status Register (BUSnERRSTAT) sections in the Hardware User's Manual.

Note: The DTC does not receive bus errors, so its operation is not affected by bus errors.

14. 24-Bit Sigma-Delta A/D Converter (SDADC24)

The RA2A1 MCU Group includes one 24-bit Sigma-Delta A/D Converter. This is the only MCU Group in the RA2 family that includes an SDADC. Figure 29 and Figure 30 list specifications of SDADC24 converter. Refer to the *24-bit Sigma-Delta A/D Converter (SDADC24)* chapter in the RA2A1 MCU *Hardware User's Manual* for more details.

Parameter	Specifications
Input channel	Single-ended input mode: Up to 10 channels*1 (external inputs: 8 channels, input from the internal OPAMP: 2 channels) Differential input mode: Up to 5 channels (external inputs: 4 channels, input from the internal OPAMP: 1 channels)
A/D conversion method	Sigma-delta conversion method
Resolution	24 bits
Analog input	<ul style="list-style-type: none"> Single-ended input <ul style="list-style-type: none"> Conversion is possible with single-ended input on both positive and negative channels. Differential input.
Oversampling frequency	<ul style="list-style-type: none"> Normal A/D conversion mode: 1 MHz Low-power A/D conversion mode: 0.125 MHz.
Power control	<ul style="list-style-type: none"> Power-on/power-off can be selected for VBIAS, PGA, and sigma-delta A/D converter power Power-on/power-off can be selected for ADBGR, SBIAS, and ADREG power VREF reference voltage (SBIAS/VREFI) can be set (step: 0.2 V, range: 0.8 to 2.4 V) Note: 2.4 V can be set in external VREF (VREFI) mode only Sensor reference voltage (SBIAS) can be activated independently.
Programmable gain instrumentation amplifier (PGA)	<ul style="list-style-type: none"> The gain of an instrumentation amplifier can be set for each channel. ($\times 1$ to $\times 32$ can be set by a combination of G_{SET1} and G_{SET2}.) <ul style="list-style-type: none"> G_{SET1} range of the previous-stage amplifier: 1, 2, 3, 4, 8 G_{SET2} range of the next-stage amplifier: 1, 2, 4, 8 The offset voltage can be adjusted for each channel by using a D/A converter connected to the next-stage amplifier <ul style="list-style-type: none"> Offset voltage adjustment (-164 to +164 mV, 31 levels: 5 bits) PGA offset can be measured as self-diagnosis Disconnection detection assist: possible on both positive and negative sides in single-ended input mode.
Data registers	<ul style="list-style-type: none"> One A/D conversion result register and one A/D conversion average value register: <ul style="list-style-type: none"> The channel number that corresponds to an A/D conversion result can be checked with a special register An overflow flag is provided for A/D conversion results Differential input mode: code is 2's complement Single-ended input mode: straight binary Reverse output can be selected for the conversion results of the single-ended negative channel.
Operation clock	<ul style="list-style-type: none"> The 24-bit sigma-delta A/D converter reference clock is generated from the peripheral clock output by the clock generation circuit according to the SDADC24 operation mode. 1/1, 1/2, 1/3, 1/4, 1/5, 1/6, 1/8, 1/12, or 1/16 can be selected The SDADC24 reference clock/oversampling clock changes according to the mode as follows: <ul style="list-style-type: none"> Normal A/D conversion mode: 4 MHz/1 MHz Low-power A/D conversion mode: 500 kHz/125 kHz. <p>Note: When the A/D converter is used in low-power A/D conversion mode, the specified frequency of the SDADC24 reference clock is divided by 8 by using an internal frequency divider.</p>
Conversion start condition	<ul style="list-style-type: none"> Software trigger Hardware trigger (ELC_SDADC24).
Operation mode	<ul style="list-style-type: none"> Continuous scan mode Single scan mode One-shot operation.
Oversampling rate	<ul style="list-style-type: none"> 64, 128, 256, 512, 1024, or 2048 can be selected Can be set for each channel.

Figure 29. SDADC24 Specifications (1 of 2)

Parameter	Specifications
A/D conversion count	<ul style="list-style-type: none"> The A/D conversion count can be set and the A/D conversion count specification mode can be selected for 1 AUTOSCAN cycle. <ol style="list-style-type: none"> For register setting values, specify 1 to 8032 (N) $N = 32 \times (2^n - 1) + m \times 2^n$ (m and n correspond to values set in the PGAC0 to PGAC4 registers. m: b16 to b20, n: b21 to b23. If N = 00h, one-shot operation that stops when one A/D conversion ends is set.) For register setting values, specify 1 to 255 (N) linearly (N corresponds to the value set in the PGAC0 to PGAC4 registers. N: b16 to b23. If N = 00h, one-shot operation that stops each time A/D conversion ends is set.) The A/D conversion count can be set for each channel.
Averaging of A/D conversion results	<ul style="list-style-type: none"> The averaging operation can be selected: <ol style="list-style-type: none"> Do not perform averaging Perform averaging, and trigger an SDADC24 conversion end interrupt each time A/D conversion occurs Perform averaging, and trigger an SDADC24 conversion end interrupt each time the average value is updated. The number of data items to be averaged can be selected as 8, 16, 32, or 64. Note: The number of data items to be averaged can be set for each channel.
Interrupt cause	<ul style="list-style-type: none"> A/D conversion end interrupt (SDADC_ADI) A/D automatic scan completion interrupt (SDADC_SCANEND) Calibration completion interrupt (SDADC_CALIEND).
SDADC24 operation	<ul style="list-style-type: none"> A/D conversion of each input channel is executed on a round-robin basis A/D conversion of a specific channel can be stopped using the permission/stop register of each channel.
Digital filter	<ul style="list-style-type: none"> Down sampling of A/D conversion results is performed using the SINC3 digital filter
SDADC24 calibration	<ul style="list-style-type: none"> Analog characteristics can be corrected by calibration (gain error and offset error)

Note 1. The number of channels that can simultaneously perform A/D conversion is up to 5 channels.

Figure 30. SDADC24 Specifications (2 of 2)

15. Operational Amplifier (OPAMP) with Configurable Switches

The RA2A1 MCU has Operational Amplifiers (OPAMP) that can be used to amplify small analog input voltages and output the amplified voltages. The MCU has a total of three differential operational amplifier units, each with two input pins and one output pin.

The operational amplifiers have the following functions:

- OPAMP0 and OPAMP1 can be used to input signals to the Low-Power Analog Comparator (ACMPLP) and the 24-bit Sigma-Delta A/D Converter (SDADC24).
- High-speed mode (high-current consumption), middle-speed mode (medium-current consumption), and low-power mode (slow-speed response) are supported, and any mode can be selected based on trade-offs between the response speed and current consumption.
- Operation can be started by a trigger from the Asynchronous General Purpose Timer (AGT).
- Operation can be stopped by a 16-bit A/D conversion end trigger.
- All units have switches that can select input signals. Additionally, OPAMP0 has a switch that can select the output pin.
- The output of the OPAMP can be output from the AMP0O to AMP2O pins without passing through the switch.
- The I/O signals of all OPAMP units can be used for the input signals to the ADC16.
- The signal output from the DAC8 and DAC12 can be used as the positive input signal for each OPAMP.
- A voltage follower circuit can be configured by connecting the output signal from an OPAMP to the negative input signal of the same OPAMP.

Renesas FSP provides an Operational Amplifier driver and driver configurator to set up OPAMPs, pin connections, etc. Figure 31 shows an example of setting up OPAMP0 to form a voltage follower with P500, P501, P502 as plus input pin, minus input pin, output pin respectively. The plus input is also set up to connect to DAC12 output internally in the following example.

The screenshot shows the 'Stacks Configuration' window in the FSP Configurator. The 'Threads' pane on the left lists 'HAL/Common' and 'g_ioport I/O Port Driver on r_ioport'. The 'Objects' pane is empty. The 'HAL/Common Stacks' pane shows four stacks: 'g_ioport I/O Port Driver on r_ioport', 'g_opamp Operational Amplifier Driver on r_opamp' (selected), 'g_dac DAC Driver on r_dac', and 'g_adc ADC Driver on r_adc'. Below the panes, a tabbed interface shows 'Summary', 'BSP', 'Clocks', 'Pins', 'Interrupts', 'Event Links', 'Stacks', and 'Components'. The 'Stacks' tab is active, displaying the configuration for 'g_opamp Operational Amplifier Driver on r_opamp'. The 'Settings' pane on the left shows 'API Info' expanded. The main table lists properties and their values.

Settings	Property	Value
API Info	Common	
	Parameter Checking	Default (BSP)
	Module g_opamp Operational Amplifier Driver on r_opamp	
	Name	g_opamp
	AGT Start Trigger Configuration (N/A unless AGT Start Trigger is Selected for the Channel)	AGT1 Compare Match Starts all OPAMPs configured for AGT Start
	Power Mode	High Speed
	Trigger Channel 0	Software Start Software Stop
	Trigger Channel 1	Software Start Software Stop
	Trigger Channel 2	Software Start Software Stop
	Trigger Channel 3	Selection N/A
	OPAMP AMP0OS	No Connection
	OPAMP AMP0PS	Connect OPAMP0 Plus Input to DAC12 Output
	OPAMP AMP0MS	Connect OPAMP0 Minus Input to (P502) OPAMP0 Output
	OPAMP AMP1PS	No Connection
	OPAMP AMP1MS	No Connection
	OPAMP AMP2PS	No Connection
	OPAMP AMP2MS	No Connection
	Pins	
	AMP+	P500
	AMP-	P501
	AMPO	P502
	AMP+	<unavailable>
	AMP-	<unavailable>
	AMPO	<unavailable>

Figure 31. Example of Setting RA2A1's OPAMP Using FSP Configurator

After an OPAMP is set up by FSP Configurator, you can use OPAMP driver's APIs such as R_OPAMP_Open and R_OPAMP_Start to initialize and start OPAMP operation. Refer to the Operational Amplifier (OPAMP) chapter in RA2A1 *Hardware User's Manual* and FSP User's Manual for more details.

16. General Layout Practices

16.1 Digital Domain vs. Analog Domain

Renesas RA2 Microcontroller devices have three primary types of pin functions: Power, Digital, and Analog.

Generally, power pins are dedicated for voltage and reference input and do not have multiple functions. Power pins are typically dedicated to specific portions, or domains, within the MCU. For example, the main supply voltage for the MCU will provide power to the digital core, many of the digital peripheral functions and many of the digital I/O pins. The digital domain can be defined as the digital circuitry, digital I/O pins, and the related power pins. Power pins which are designated for analog functions (such as AVCC0 and the associated AVSS0) supply specific analog circuitry within the MCU, which is separate from the digital domain circuitry. The analog domain can be defined as the analog circuitry, analog I/O pins, and the related power pins.

Digital signals are typically repetitive, switched patterns that are associated with periodic clocks. The transitions on digital signals tend to be relatively sharp edges, with stable levels of high or low between the transitions. Each signal must be stable at an acceptable voltage level, referred to as a logic state, within a specified timeframe. The state of the signal is typically sampled at predetermined clock intervals, using the edge transition of a clock to evaluate the associated data signals. Small variations in the voltage level of digital signals are typically acceptable, as long as the level remains within a specified range. However, large external influences on digital signals can have an acute influence on a digital signal, which can result in an incorrect logic state at the moment when the data is sampled.

Analog signals are usually quite different. Analog signals may be periodic, but the evaluation of an analog signal is typically a measurement of voltage over a range instead of logic state. The voltage level of an analog signal is sampled based on a specific trigger event, and the resulting measurement is processed using the analog circuitry in the MCU. The accuracy of an analog measurement is directly related to the accuracy of the sampled voltage level. Any unwanted external influence which may change the voltage level of an analog input signal, even slightly, can influence the accuracy of the measurement.

Due to the highly multiplexed nature of the I/O pins on Renesas RA2 MCU devices, many I/O pins can be used for either analog or digital functions. This can result in situations where digital and analog functions may overlap and result in data errors.

To minimize potential problems between digital and analog signal domains, consider the following guidelines:

- When assigning I/O pin functions, select pin functions such that analog pins and digital pins are physically separated as much as possible.
- Each analog signal should be separated from all other signals as much as possible.
- PCB routing should isolate each analog signal as much as possible. Avoid routing any other signals, either analog or digital, in the same area.
- Ensure that analog supply voltages and analog reference voltages include appropriate AC filters. This may be in the form of recommended capacitors located near the MCU voltage pin, or appropriate inductive filters. The goal is to provide voltage supply and reference voltage with little or no voltage ripple.
- When using dedicated power layers in a PCB design, avoid routing digital signals in the areas of analog voltages, and avoid routing analog signals in the areas of digital voltages.

For highly sensitive applications, it is highly recommended to evaluate the specific design using simulation tools to understand the effect that circuit design has on the performance. For example, this may include applications such as precision sensor designs, or very high-speed digital bus interfaces. Refer to the Electrical Characteristics chapter in the *Hardware User's Manual* for the specific requirements for each peripheral function.

16.2 High Speed Signal Design Considerations

As clock speeds for digital signals increase, the influence of external stimuli on those signals can become more significant. Some peripheral functions can be classified as High Speed digital signals. Additional design considerations should be made for high-speed digital signals.

Crosstalk is a condition where transitions on one signal have an inductive influence on another nearby signal. When this crosstalk effect is strong enough, the first signal may cause errors on the second signal. To reduce the effects of crosstalk, use the following general PCB routing guidelines.

- Provide sufficient space between routed signals on the same routing layer. Generally, keep a minimum of one trace width space between signals of the same digital group, and a minimum of 3-5 trace widths space between signals of different digital groups.
- Provide extra space between clock signals and data signals on the same routing layer. Generally, keep a minimum of 3-5 trace widths space between clocks and any other digital signals.
- Avoid parallel routing of digital signals on any adjacent routing layers. If signals must be routed on adjacent signals layers, try to use only orthogonal crossings wherever possible.

If possible, separate PCB signal layers using power or ground layers between signal layers. The solid copper of the power or ground layer can act as a shield for the digital signals.

Each standardized interface will have specific requirements. To ensure that the PCB is designed to avoid signal crosstalk problems, we strongly suggest referring to the relevant standards for each interface in the design.

16.3 Signal Group Selections

Some pin names have an added `_A`, `_B`, `_C`, `_D`, `_E`, or `_F` suffix to indicate signal groups. For RA2 devices, the suffix can be ignored when assigning functionality. It is safe to select the most convenient pin assignment for each function signal.

Refer to the sections Peripheral Select Settings for each Product and Notes on the PmnPFS Register Setting in the I/O Ports chapter of the *Hardware User's Manual*.

17. References

The following documents were used in creating this Quick Design Guide. Visit [Renesas website](#) for the latest version of each of these documents.

Reference	Document Number	Description
1	R01UH0888	Renesas RA2A1 Group, User's Manual: Hardware
2	R01UH0852	Renesas RA2E1 Group, User's Manual: Hardware
3	R01UH0853	Renesas RA2L1 Group, User's Manual: Hardware
4	R01UH0919	Renesas RA2E2 Group, User's Manual: Hardware

Website and Support

Visit the following URLs to learn about key elements of the RA family, download components and related documentation, and get support.

RA Product Information	www.renesas.com/ra
RA Product Support Forum	www.renesas.com/ra/forum
RA Flexible Software Package	www.renesas.com/FSP
Renesas Support	www.renesas.com/support

Revision History

Rev.	Date	Description	
		Page	Summary
1.00	Sep.14.21	—	Initial release
1.01	Feb.24.22	—	Minor corrections
1.02	Mar.29.23	5-8	Removed references to external pull up resistors on emulator signals
1.03	Dec.04.23	3, 27	Updated VCC_DCDC*2 value in table 1, and the setting of PDR register in section 9.6.

General Precautions in the Handling of Microprocessing Unit and Microcontroller Unit Products

The following usage notes are applicable to all Microprocessing unit and Microcontroller unit products from Renesas. For detailed usage notes on the products covered by this document, refer to the relevant sections of the document as well as any technical updates that have been issued for the products.

1. 1. Precaution against Electrostatic Discharge (ESD)

A strong electrical field, when exposed to a CMOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop the generation of static electricity as much as possible, and quickly dissipate it when it occurs. Environmental control must be adequate. When it is dry, a humidifier should be used. This is recommended to avoid using insulators that can easily build up static electricity.

Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors must be grounded. The operator must also be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions must be taken for printed circuit boards with mounted semiconductor devices.

2. 2. Processing at power-on

The state of the product is undefined at the time when power is supplied. The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the time when power is supplied. In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the time when power is supplied until the reset process is completed. In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the time when power is supplied until the power reaches the level at which resetting is specified.

3. 3. Input of signal during power-off state

Do not input signals or an I/O pull-up power supply while the device is powered off. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Follow the guideline for input signal during power-off state as described in your product documentation.

4. 4. Handling of unused pins

Handle unused pins in accordance with the directions given under handling of unused pins in the manual. The input pins of CMOS products are generally in the high-impedance state. In operation with an unused pin in the open-circuit state, extra electromagnetic noise is induced in the vicinity of the LSI, an associated shoot-through current flows internally, and malfunctions occur due to the false recognition of the pin state as an input signal become possible.

5. 5. Clock signals

After applying a reset, only release the reset line after the operating clock signal becomes stable. When switching the clock signal during program execution, wait until the target clock signal is stabilized. When the clock signal is generated with an external resonator or from an external oscillator during a reset, ensure that the reset line is only released after full stabilization of the clock signal. Additionally, when switching to a clock signal produced with an external resonator or by an external oscillator while program execution is in progress, wait until the target clock signal is stable.

6. 6. Voltage application waveform at input pin

Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between V_{IL} (Max.) and V_{IH} (Min.) due to noise, for example, the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between V_{IL} (Max.) and V_{IH} (Min.).

7. 7. Prohibition of access to reserved addresses

Access to reserved addresses is prohibited. The reserved addresses are provided for possible future expansion of functions. Do not access these addresses as the correct operation of the LSI is not guaranteed.

8. 8. Differences between products

Before changing from one product to another, for example to a product with a different part number, confirm that the change will not lead to problems. The characteristics of a microprocessing unit or microcontroller unit products in the same group but having a different part number might differ in terms of internal memory capacity, layout pattern, and other factors, which can affect the ranges of electrical characteristics, such as characteristic values, operating margins, immunity to noise, and amount of radiated noise. When changing to a product with a different part number, implement a system-evaluation test for the given product.

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(Rev.5.0-1 October 2020)

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